

# Measurement of Beam Current

The beam current is the basic quantity of the beam.

- It is the first check of the accelerator functionality
- It has to be determined in an absolute manner
- Important for transmission measurement and to prevent for beam losses.

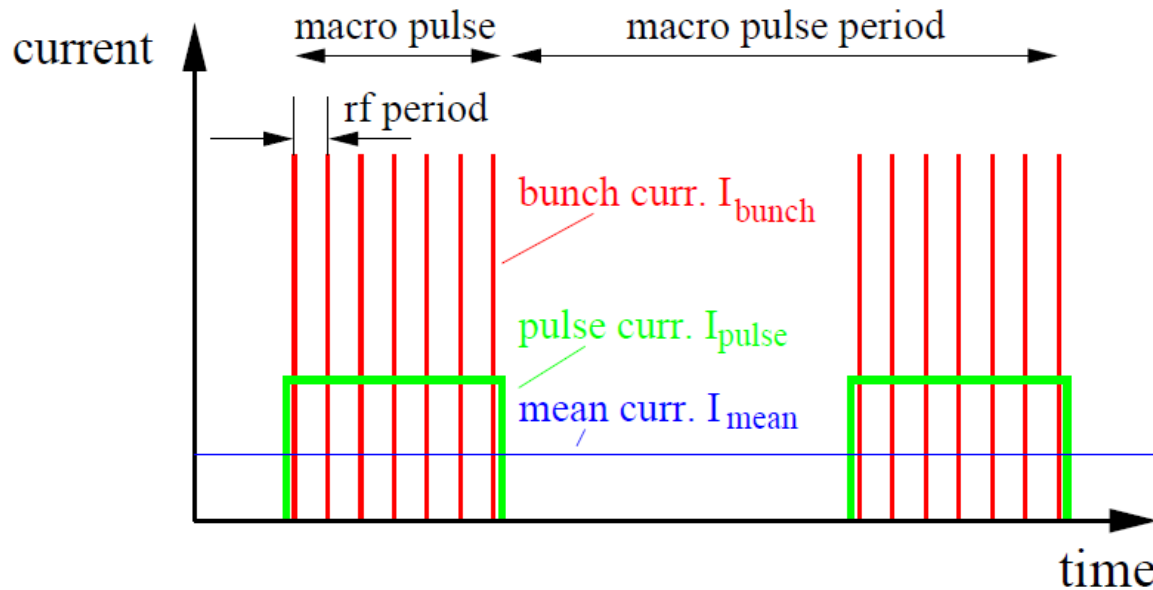
## Different devices are used:

- **Transformers:** Measurement of the beam's **magnetic field**
  - They are non-destructive. No dependence on beam energy
  - They have lower detection threshold.
- **Faraday cups:** Measurement of the beam's **electrical charges**
  - They are destructive. For low energies only
  - Low currents can be determined.
- **Particle detectors:** Measurement of the particle's **energy loss** in matter
  - Examples are scintillators, ionization chambers, secondary e<sup>-</sup> emission monitors
  - Used for low currents at high energies e.g. for slow extraction from a synchrotron.

**Generally:** Beam instruments are mounted outside of rf cavities to prevent for electro-magnetic interference from the high field; only inside cyclotrons some BI.

# Beam Structure of a pulsed LINAC

Pulsed LINACs and cyclotrons used for injection to synchrotrons with  $t_{pulse} \approx 100 \mu s$ :



One distinguish between:

- Mean current  $I_{mean}$ 
  - long time average in [A]
- Pulse current  $I_{pulse}$ 
  - during the macro pulse in [A]
- Bunch current  $I_{bunch}$ 
  - during the bunch in [C/bunch] or [particles/bunch]

Remark: Van-de-Graaff (ele-static):  
→ no bunch structure

# Magnetic field of the beam and the ideal Transformer

➤ Beam current of  $N_{part}$  charges with velocity  $\beta$

$$I_{beam} = qe \cdot \frac{N_{part}}{t} = qe \cdot \beta c \cdot \frac{N_{part}}{l}$$

➤ cylindrical symmetry

→ only azimuthal component

$$\vec{B} = \mu_0 \frac{I_{beam}}{2\pi r} \cdot \vec{e}_\varphi$$

Example:  $I = 1\mu A$ ,  $r = 10cm \Rightarrow B_{beam} = 2pT$ , earth  $B_{earth} = 50\mu T$

**Idea: Beam as primary winding and sense by sec. winding.**

⇒ Loaded current transformer

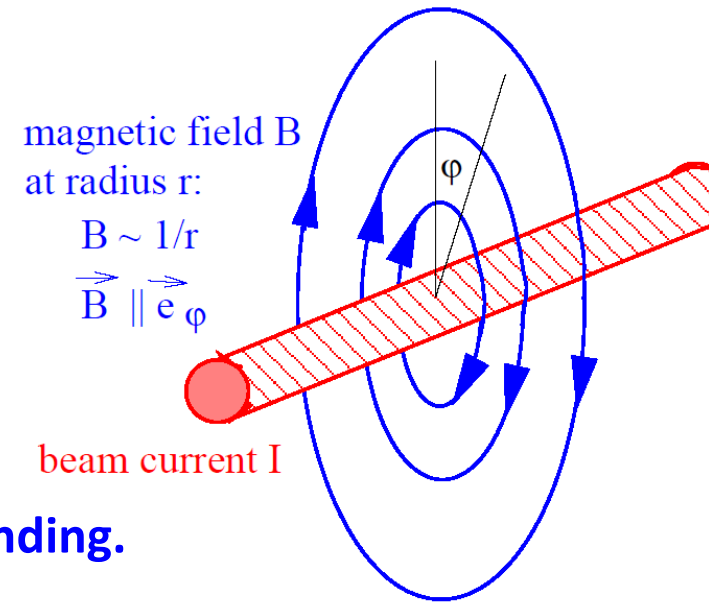
$$I_1/I_2 = N_2/N_1 \Rightarrow I_{sec} = 1/N \cdot I_{beam}$$

➤ Inductance of a torus of  $\mu_r$

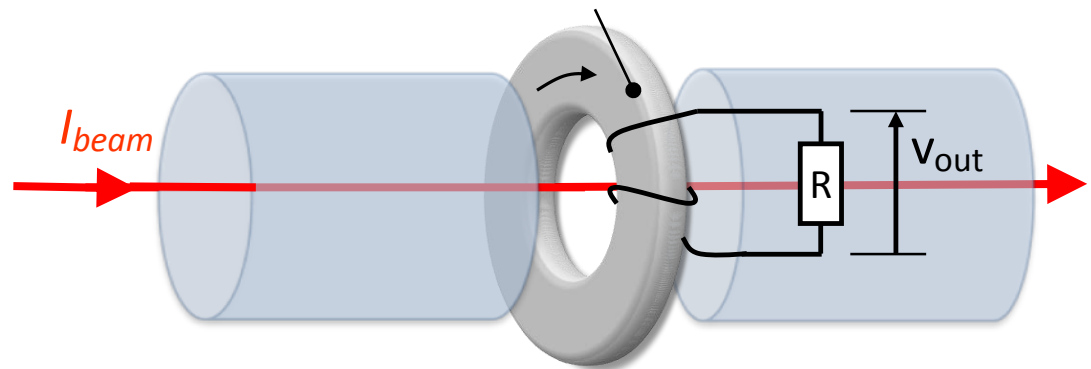
$$L = \frac{\mu_0 \mu_r}{2\pi} \cdot l N^2 \cdot \ln \frac{r_{out}}{r_{in}}$$

➤ Goal of torus: Large inductance  $L$  **and** guiding of field lines.

Definition:  $U = L \cdot di/dt$

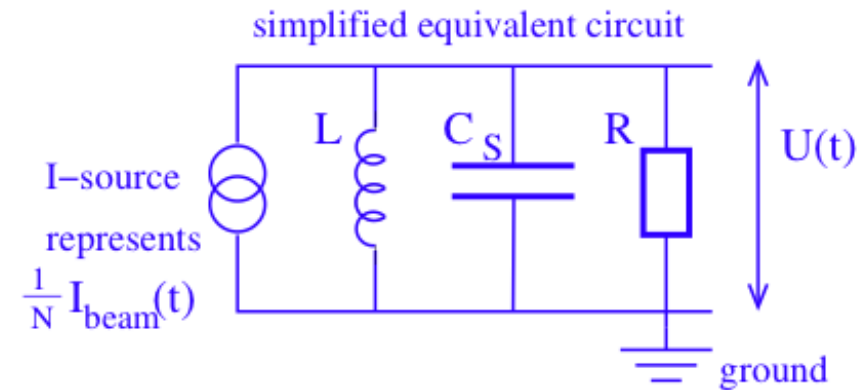
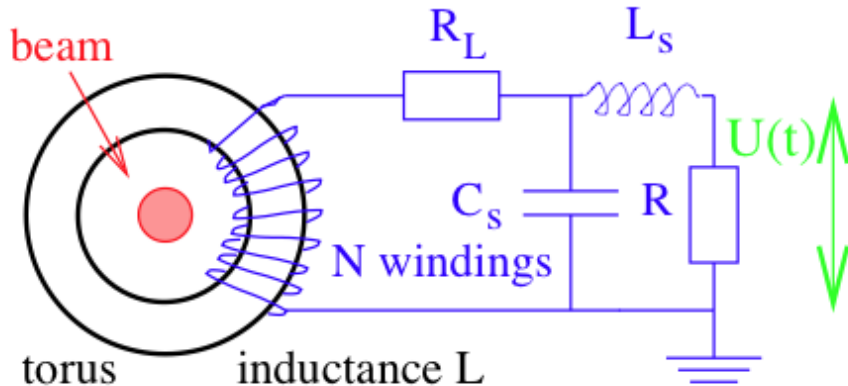


Torus to guide the magnetic field



## Simplified electrical circuit of a passively loaded transformer:

### passive transformer



A voltage is measured:  $U = R \cdot I_{sec} = R/N \cdot I_{beam} \equiv S \cdot I_{beam}$

with **S sensitivity [V/A]**,

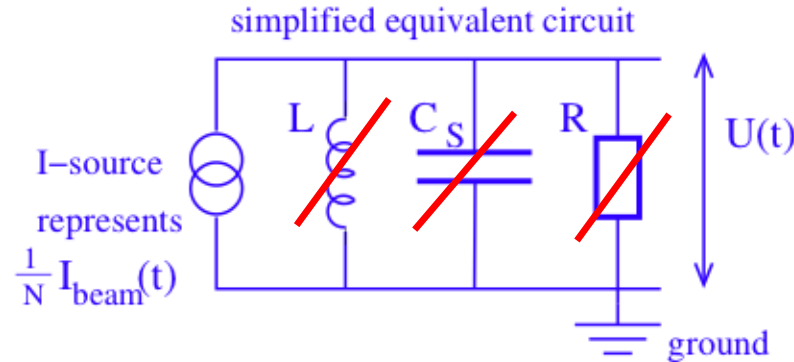
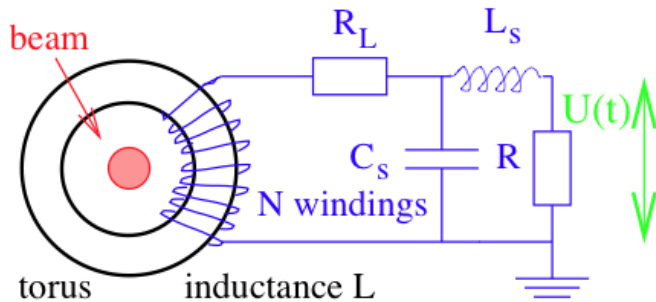
equivalent to transfer function or transfer impedance **Z**

Equivalent circuit for analysis of sensitivity and bandwidth  
(disregarding the loss resistivity  $R_L$ )

# Bandwidth of a Passive Transformer

## Analysis of a simplified electrical circuit of a passively loaded transformer:

### passive transformer

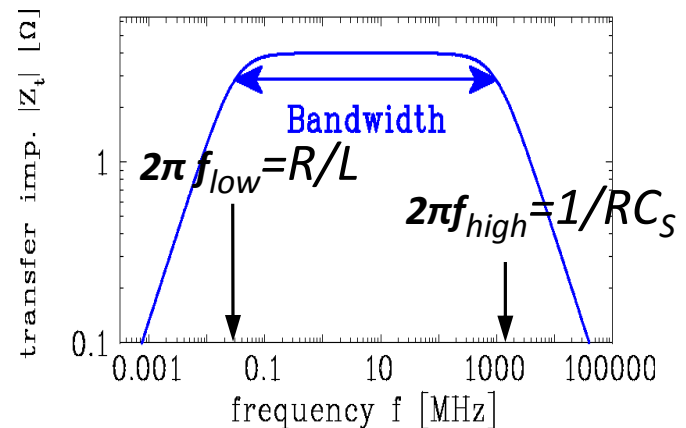


For this parallel shunt:

$$\frac{1}{Z} = \frac{1}{i\omega L} + \frac{1}{R} + i\omega C_s \Leftrightarrow Z = \frac{i\omega L}{1 + i\omega L/R - \omega L/R \cdot \omega R C_s}$$

- **Low frequency**  $\omega \ll R/L$  :  $Z \rightarrow i\omega L$   
i.e. no dc-transformation
- **High frequency**  $\omega \gg 1/RC_s$  :  $Z \rightarrow 1/i\omega C_s$   
i.e. current flow through  $C_s$
- **Working region**  $R/L < \omega < 1/RC_s$  :  $Z \simeq R$   
i.e. voltage drop at R and sensitivity  $S=R/N$ .

No oscillations due to over-damping by low  $R = 50 \Omega$  to ground.



# Response of the Passive Transformer: Rise and Droop Time

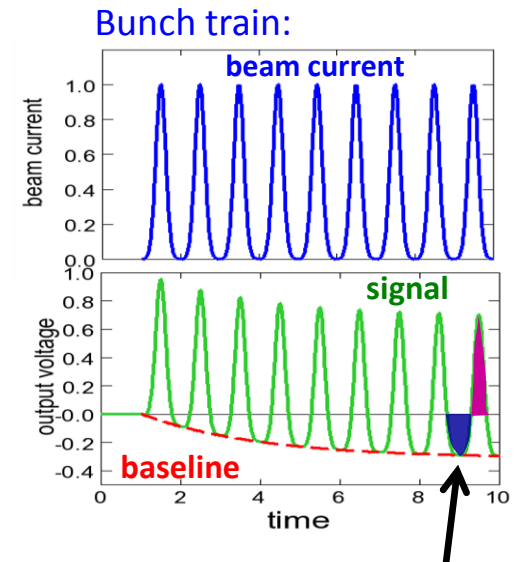
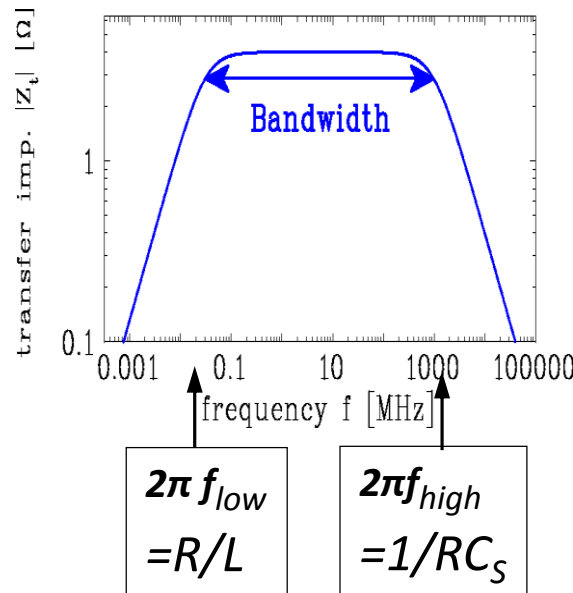
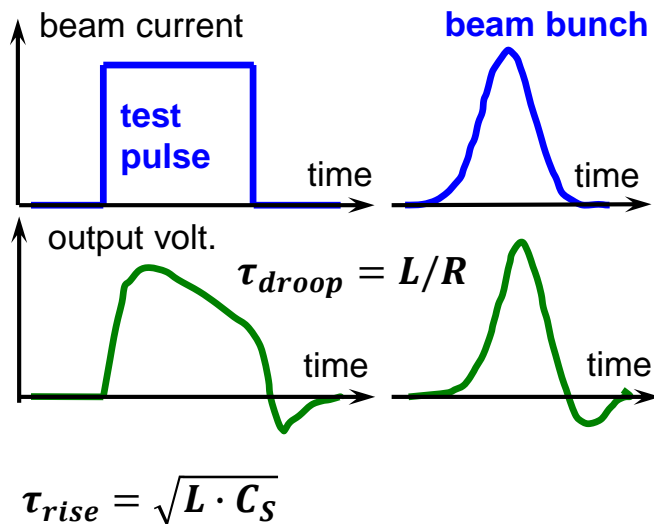
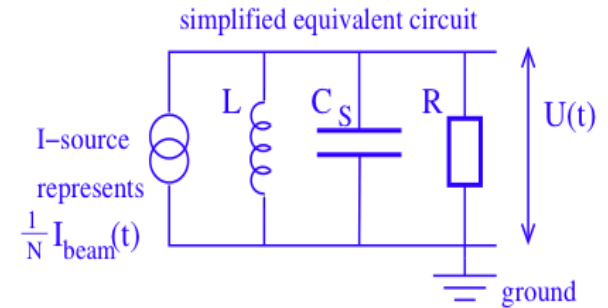
## Time domain description:

Droop time:  $\tau_{droop} = 1/(2\pi f_{low}) = L/R$

Rise time:  $\tau_{rise} = 1/(2\pi f_{high}) = 1/RC_S$  (ideal without cables)

Rise time:  $\tau_{rise} = 1/(2\pi f_{high}) = \nu L_S C_S$  (with cables)

$R_L$ : loss resistivity,  $R$ : for measuring.



**Baseline:**  $U_{base} \propto 1 - \exp(-t/\tau_{droop})$   
**positive & negative areas are equal**

# Example for Fast Current Transformer

From  
Company Bergoz



Ø 200 mm

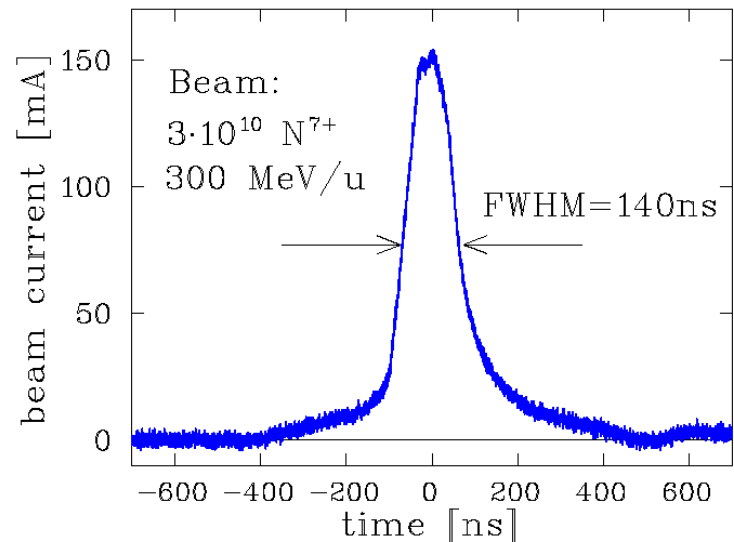
For bunch beams e.g. transfer between synchrotrons  
typical bandwidth of  $2 \text{ kHz} < f < 1 \text{ GHz}$

$\Leftrightarrow 1 \text{ ns} < t_{\text{batch}} < 200 \mu\text{s}$  is well suited

Example GSI type:

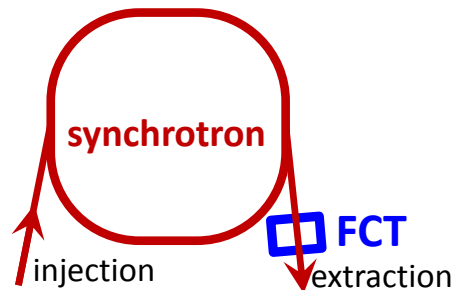
Inner / outer radius	70 / 90 mm
Permeability	$\mu_r \approx 10^5$ for $f < 100\text{kHz}$ $\mu_r \propto 1/f$ above
Windings	10
Sensitivity	4 V/A for $R = 50 \Omega$
Droop time $\tau_{\text{droop}} = L/R$	0.2 ms
Rise time $\tau_{\text{rise}} = \sqrt{L_S C_S}$	1 ns
Bandwidth	2 kHz ... 500 MHz

Fast extraction from GSI synchrotron:



Numerous application e.g.:

- Transmission optimization
- Bunch shape measurement
- Input for synchronization of 'beam phase'



# Example for Fast Current Transformer

From  
Company Bergoz



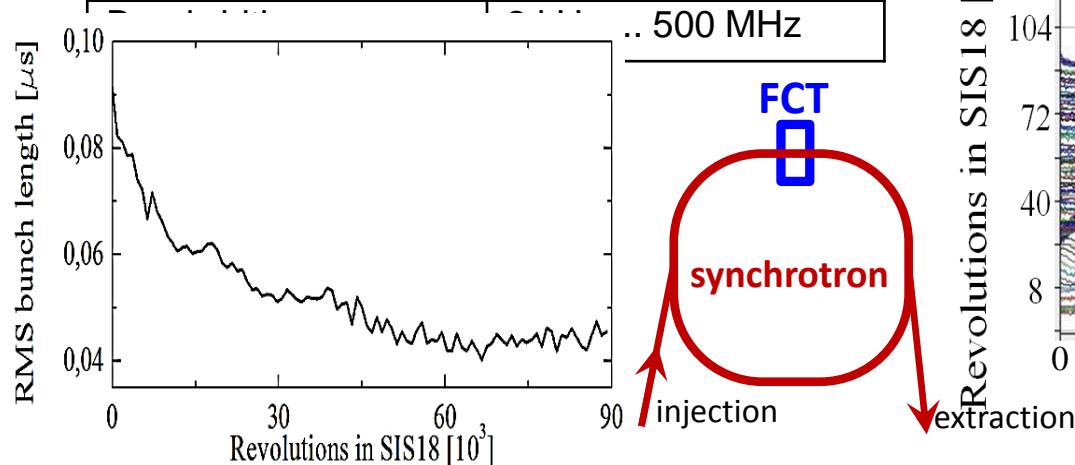
Ø 200 mm

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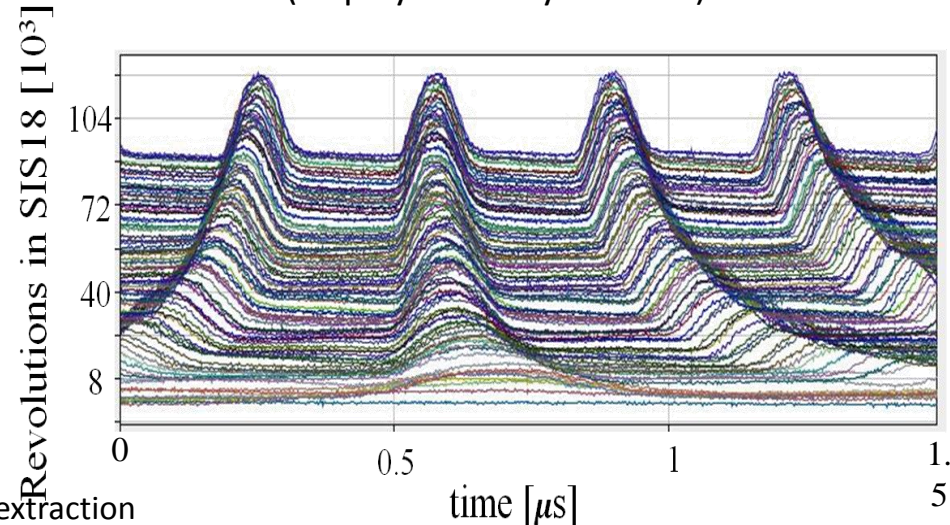
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Example:  $U^{73+}$  from 11 MeV/u ( $\beta = 15\%$ ) to 350 MeV/u within 300 ms (displayed every 0.15 ms)





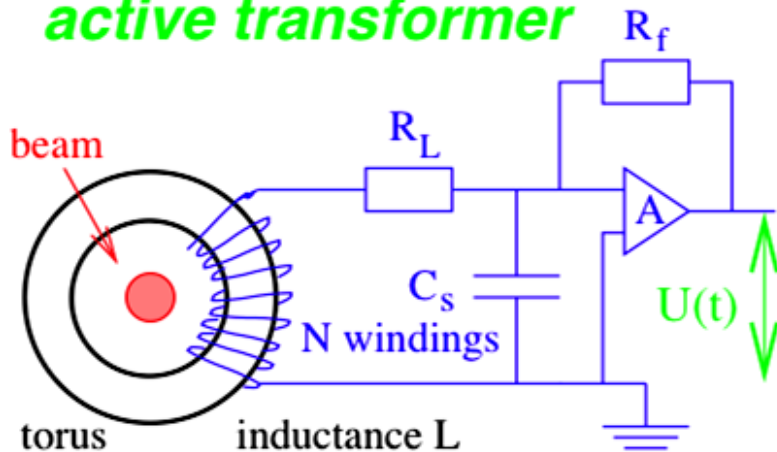
# 'Active' Transformer with longer Droop Time

## Active Transformer or Alternating Current Transformer ACT:

uses a trans-impedance amplifier (I/U converter) to  $R \approx 0 \Omega$  load impedance i.e. a current sink  
 + compensation feedback  
 $\Rightarrow$  longer droop time  $\tau_{droop}$

Application: measurement of longer  $t > 10 \mu s$  e.g. at pulsed LINACs

### active transformer



The input resistor is for an op-amp:  $R_f/A \ll R_L$

$$\Rightarrow \tau_{droop} = L/(R_f/A + R_L) \approx L/R_L$$

Droop time constant can be up to 1 s!

The feedback resistor is also used for range switching.

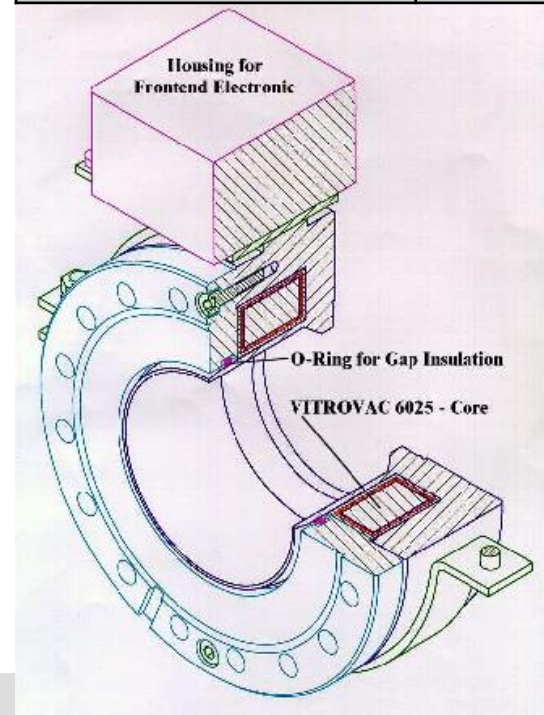
An additional active feedback loop is used to compensate the droop.

# 'Active' Transformer Realization

Active transformer for the measurement of long  $t > 10 \mu\text{s}$  pulses e.g. at pulsed LINACs



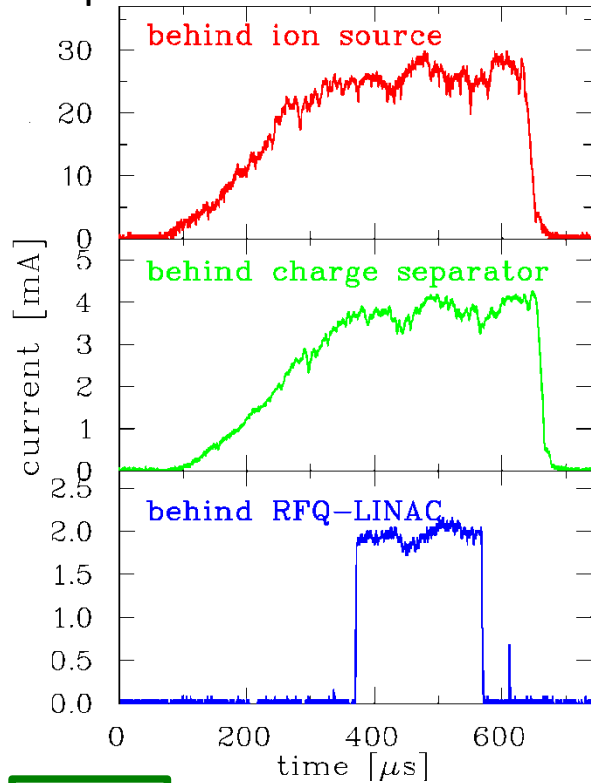
Inner / outer radius	30 / 45 mm
Permeability	$\mu_r \approx 10^5$ for $f < 100\text{kHz}$ $\mu_r \propto 1/f$ above
Windings	2x10 crossed
Max. sensitivity	$10^6$ V/A with amplifier
Current resolution	$0.2 \mu\text{A}$ for full BW
Droop	0.5 % per 5 ms
Rise time	200 ns
Bandwidth	2 kHz ... 1 MHz



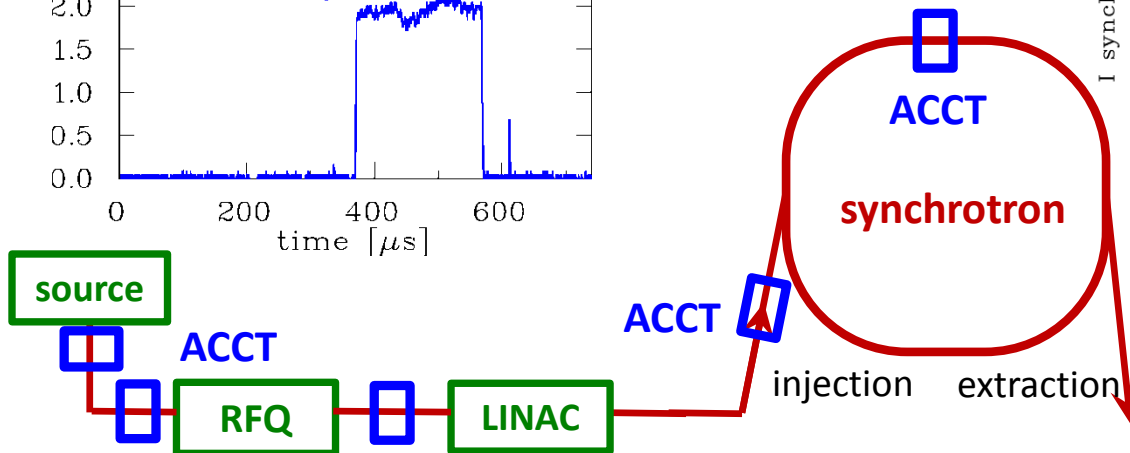
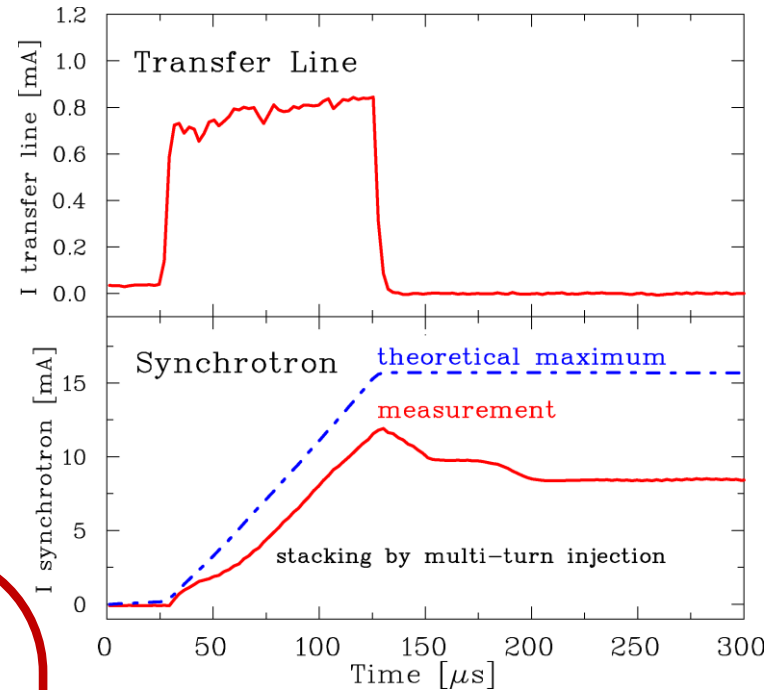
# 'Active' Transformer Measurement

Active transformer for the measurement of long  $t > 10 \mu\text{s}$  pulses e.g. at pulsed LINACs

**Example:** Transmission and macro-pulse shape for  $\text{Ni}^{2+}$  beam at GSI LINAC



**Example:** Multi-turn injection of a  $\text{Ni}^{26+}$  beam into GSI Synchrotron, 5  $\mu\text{s}$  per turn

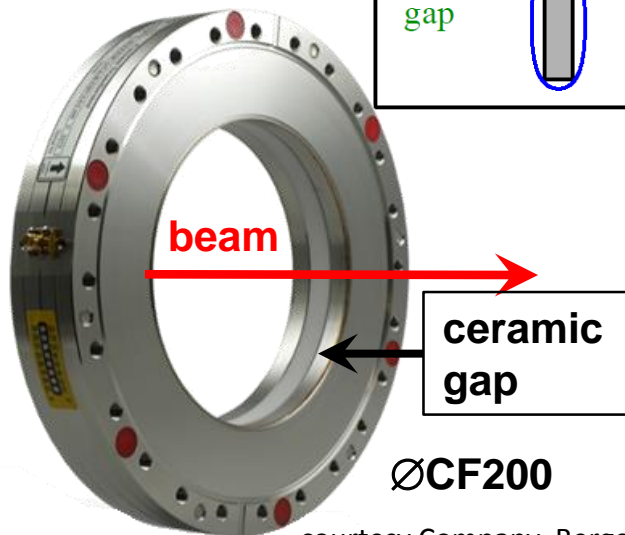
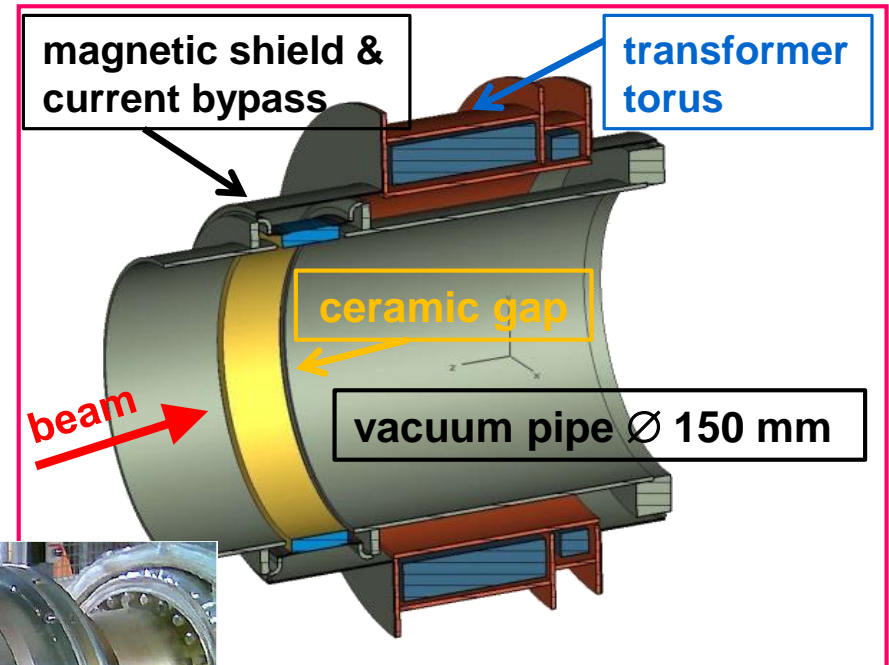
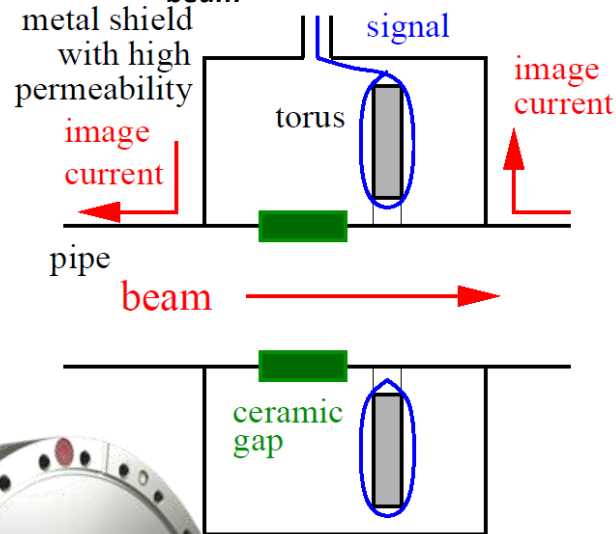


→ Transformer are frequently used for operation.

# Shielding of a Transformer

## Task of the shield:

- The image current of the walls have to be bypassed by a gap and a metal housing.
- This housing uses  $\mu$ -metal and acts as a shield of external B-field  
(remember:  $I_{beam} = 1 \mu A, r = 10 \text{ cm} \Rightarrow B_{beam} = 2 \text{ pT}, \text{ earth field } B_{earth} = 50 \mu T$ )



courtesy Company Bergoz

# Design Criteria for a Current Transformer

## Criteria:

1. The output voltage is  $U \propto 1/N \Rightarrow$  low number of windings for large signal.
2. For a longer droop time, a large inductance  $L$  is required due to  $\tau_{droop} = L/R$ :  
 $L \propto N^2$  and  $L \propto \mu_r$  ( $\mu_r \approx 10^5$  for amorphous alloy)
3. For a large bandwidth the integrating capacitance  $C_s$  should be low  $\tau_{rise} = \sqrt{L_s C_s}$

## Depending on applications the behavior is influenced by external elements:

- **Passive transformer:**  $R = 50 \Omega$ ,  $\tau_{rise} \approx 1$  ns for short pulses

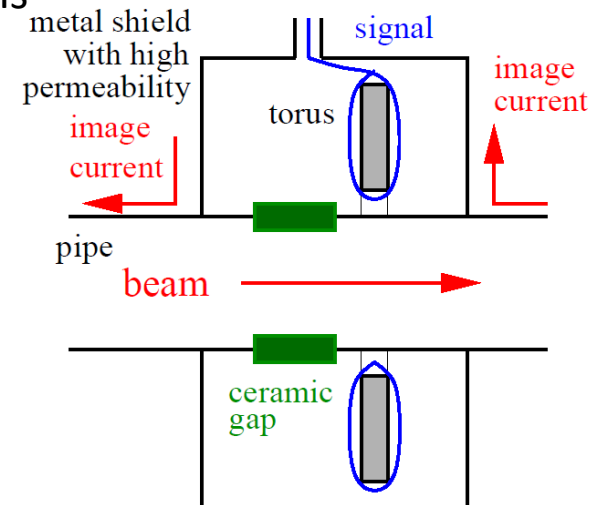
**Application:** Transfer between synchrotrons :  $100 \text{ ns} < t_{pulse} < 10 \mu\text{s}$

- **Active transformer:** Current sink by I/U-converter,  $\tau_{droop} \approx 1$  s for long pulses

**Application:** macro-pulses at LINACs :  $100 \mu\text{s} < t_{pulse} < 10 \text{ ms}$

## General:

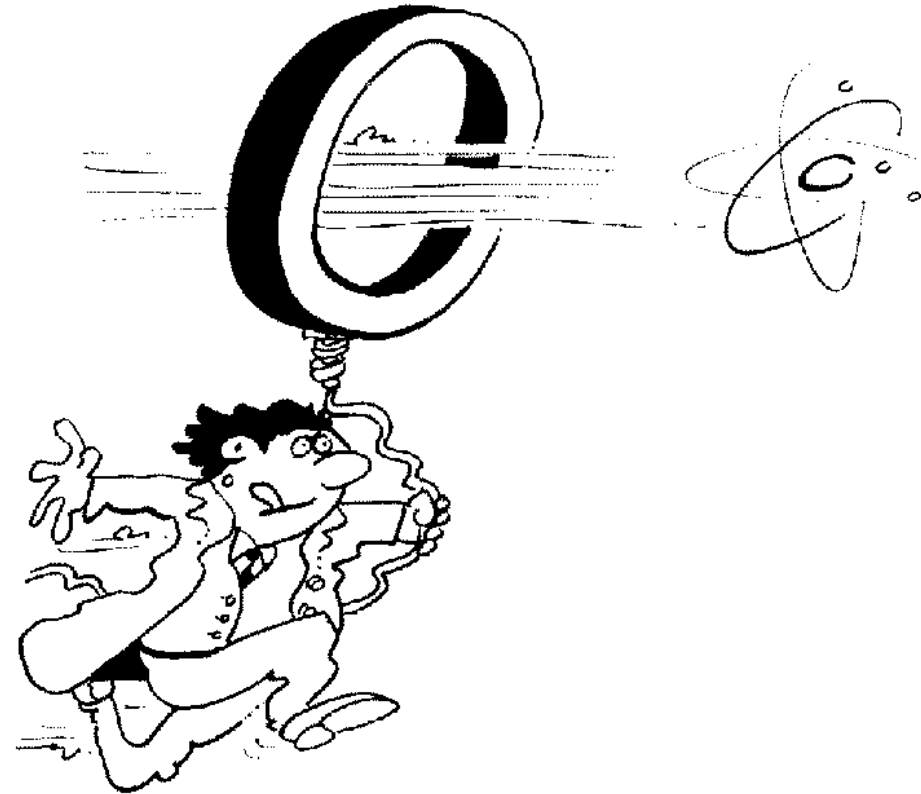
- The beam pipe has to be intersected to prevent the flow of the image current through the torus
- The torus is made of 25  $\mu\text{m}$  isolated flat ribbon spiraled to get a torus of  $\approx 15$  mm thickness, to have large electrical resistivity
- Additional winding for calibration with current source



## The active transformer ACCT



## The passive, fast transformer FCT



Cartoons by Company Bergoz, Saint Genis

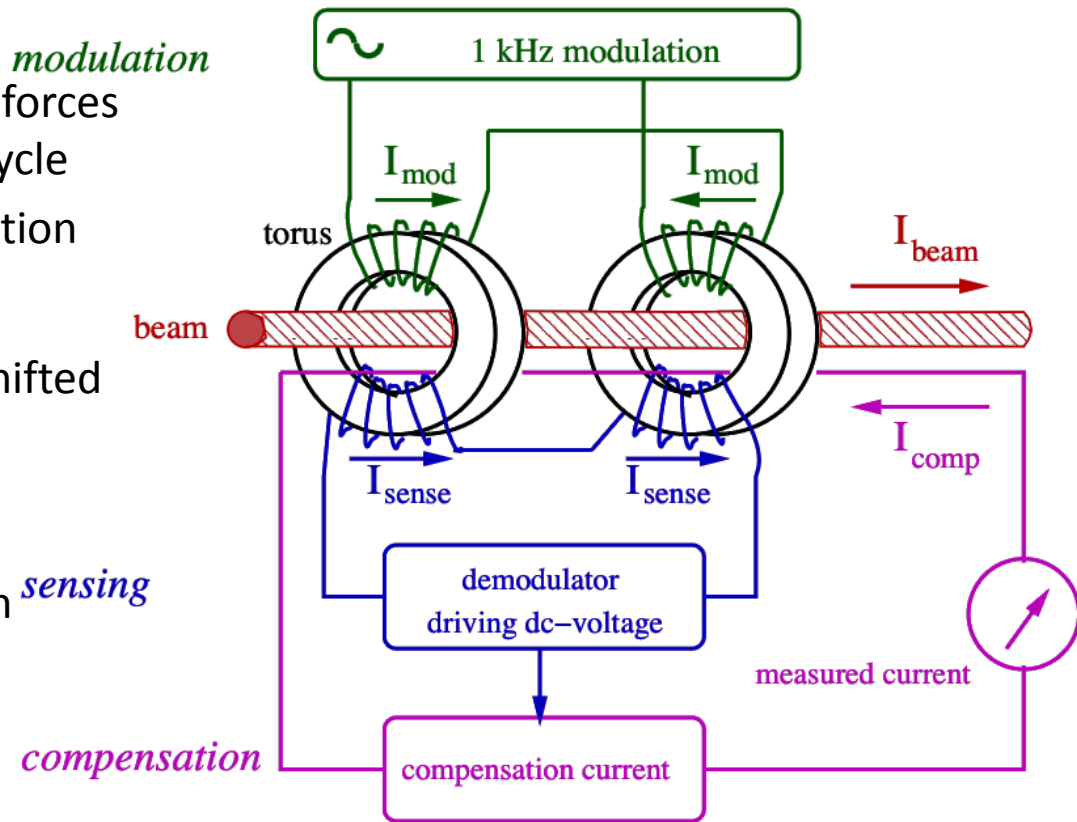
# The dc Transformer

How to measure the DC current? The current transformer discussed sees only B-flux *changes*. The DC Current Transformer (DCCT) → look at the magnetic saturation of two torii.

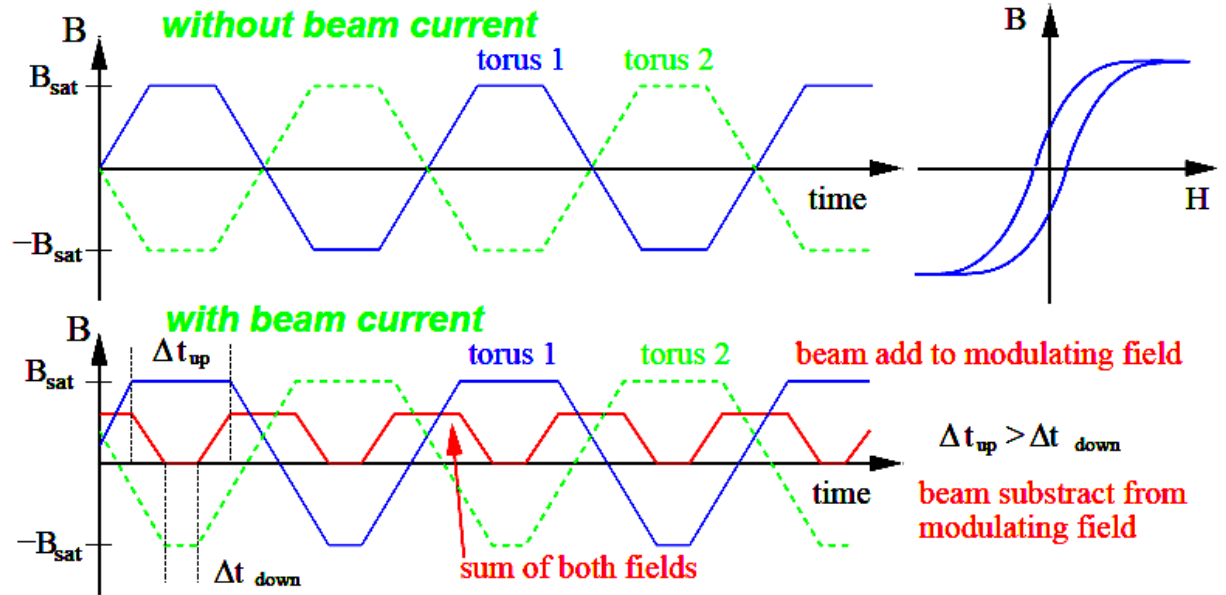
## Depictive statement:

A single transformer needs varying beam. The trick is to ‘switch two transformers’!

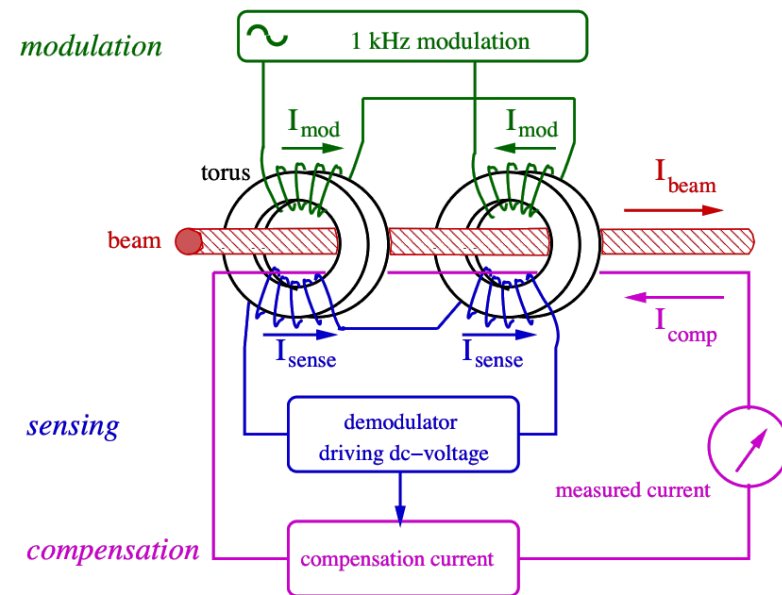
- **Modulation** of the primary windings forces both torii into saturation, twice per cycle
- **Sense windings** measure the modulation signal and cancel each other.
- But with the  $I_{beam}$ , the saturation is shifted and  $I_{sense}$  is not zero
- **Compensation current** adjustable until  $I_{sense}$  is zero once again



# The dc Transformer



- **Modulation without beam:**  
typically about 1 kHz to saturation  
→ **no** net flux
- **Modulation with beam:**  
saturation is reached at different times, → net flux
- **Net flux:** double frequency than modulation
- **Feedback:** Current fed to compensation winding for larger sensitivity
- **Two magnetic cores:** Must be very similar.





# The dc Transformer Realization

Example: The DCCT at GSI synchrotron  
(designed 1990 at GSI):

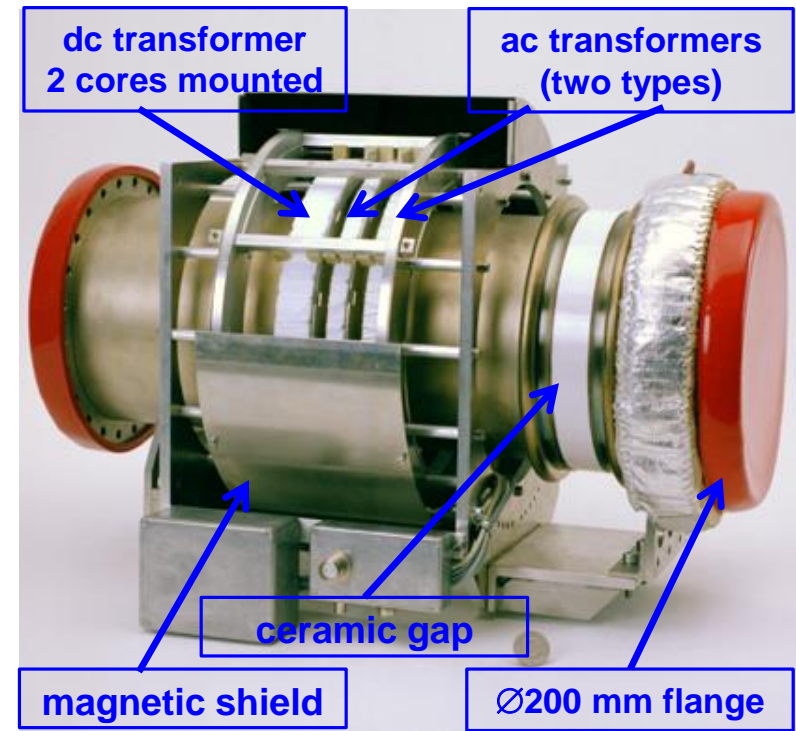
Torus radii	$r_i = 135 \text{ mm}$ $r_o = 145 \text{ mm}$
Torus thickness	$d = 10 \text{ mm}$
Torus permeability	$\mu_r = 10^5$
Saturation inductance	$B_{\text{sat}} = 0.6 \text{ T}$
Number of windings	16 for modulation & sensing 12 for feedback
Resolution	$I_{\text{beam}}^{\text{min}} = 2 \text{ } \mu\text{A}$
Bandwidth	$\Delta f = \text{dc} \dots 20 \text{ kHz}$
Rise time constant	$\tau_{\text{rise}} = 10 \text{ } \mu\text{s}$
Temperature drift	$1.5 \text{ } \mu\text{A}/^\circ\text{C}$

Recent commercial product specification (Bergoz NPCT):

Most parameters are comparable the GSI-model

Temperature coefficient:  $0.5 \text{ } \mu\text{A}/^\circ\text{C}$

Resolution:  $\approx 10 \text{ } \mu\text{A}$  (i.e. not optimized)



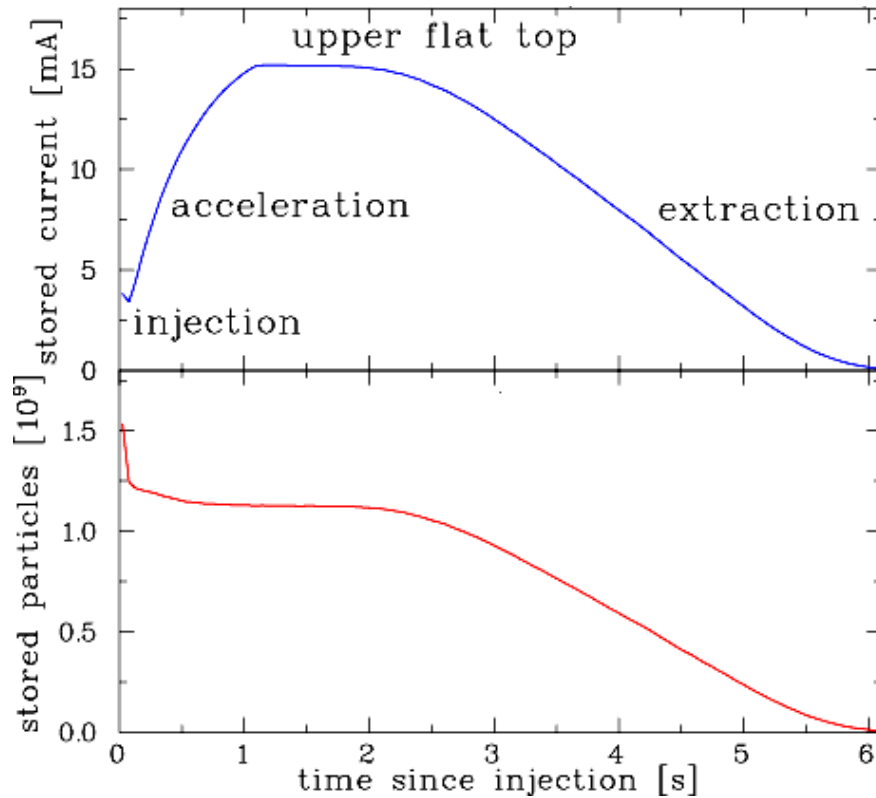
In-flange NPCT with 96-mm aperture

# Measurement with a dc Transformer

**Example:** The DCCT at GSI synchrotron:

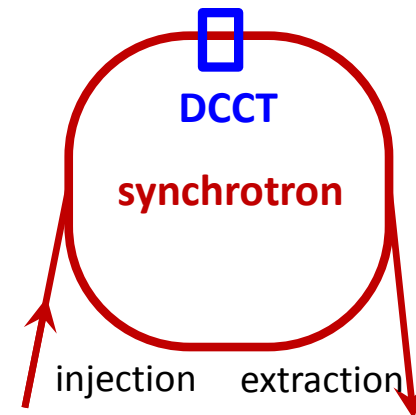
⇒ Observation of beam behavior with 20 μs time resolution → most important operation tool.

**Example:** U<sup>73+</sup> accelerated from 11.4 MeV/u ( $\beta = 15.5\%$ ) to 750 MeV/u ( $\beta = 84\%$ )



## Important parameters:

- **Detection threshold: 1 μA (= resolution)**
- Bandwidth: dc to 20 kHz
- Rise-time: 20 μs
- Temperature drift: 1.5 μA/°C  
⇒ compensation required.



Careful shielding against external fields with  $\mu$ -metal.

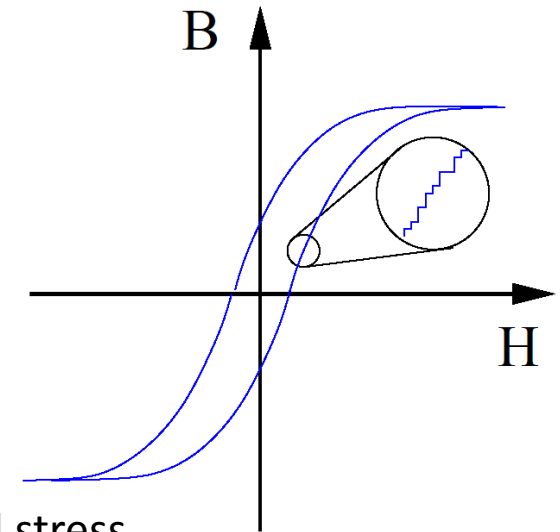
- High resistivity of the core material to prevent for eddy current  
⇒ thin, insulated strips of alloy.
- Barkhausen noise due to changes of Weiss domains  
⇒ unavoidable limit for **DCCT**.
- Core material with low changes of  $\mu_r$  due to temperature and stress  
⇒ low micro-phonic pick-up.
- Thermal noise voltage  $U_{eff} = \sqrt{4k_B T \cdot R \cdot f}$   
⇒ design for only required bandwidth  $f$ , low input resistor  $R$  preferred.
- Preventing for flow of secondary electrons through the core  
⇒ need for well controlled beam centering close to the transformer.

⇒ **The lowest measurable current:  $\approx 1 \mu\text{A}$  for DCCT**

**$\approx 30 \mu\text{A}$  for FCT with 500 MHz bandwidth**

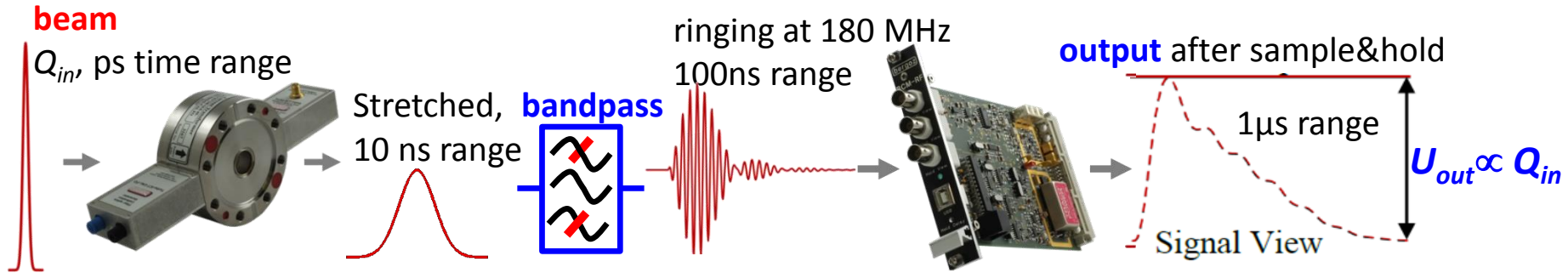
**$\approx 0.3 \mu\text{A}$  for ACCT with 1 MHz bandwidth.**

**ICT short pulses:** Image charge storage → analog pulse stretching,  $Q_{min} \approx 10 \text{ fC}$ , no timing



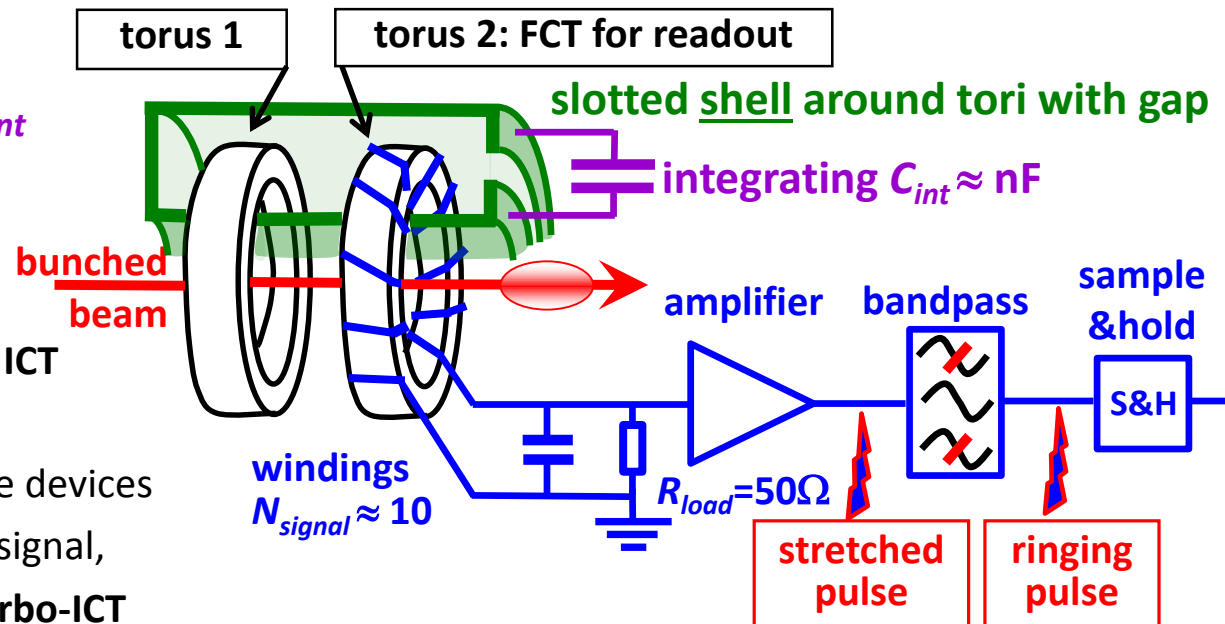
# Integrating Current Transformer ICT for short Pulses

Short, single pulse at FELs: Too short to be recorded by FCT due to rise time  $\tau_{pulse} \ll \tau_{rise} \approx 1\text{ns}$   
 $\Rightarrow$  depictive statement: 'analog stretching of signal information' yields charges per bunch



## ICT operation principle for ps pulses:

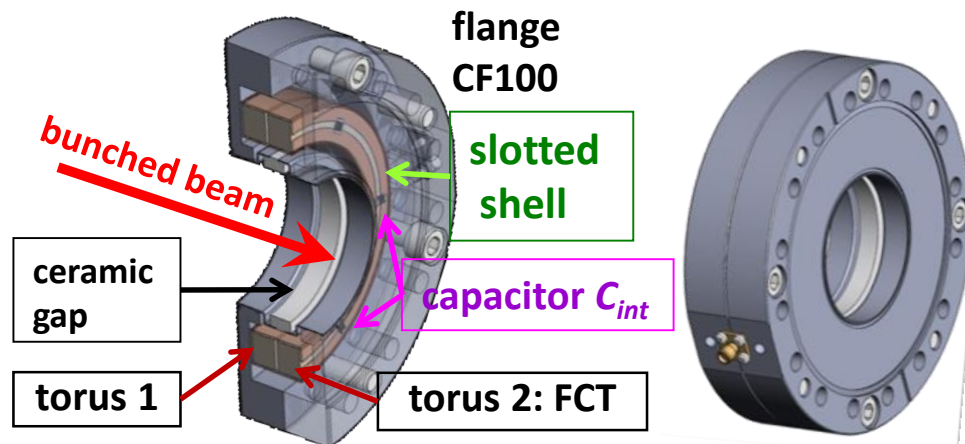
- Image current on **shell with gap**
- Storage of induced charges at  $C_{int}$
- 'Slow' recombination of charges
- Sensing this current with **FCT**  
 $\Rightarrow$  **stretched pulse**, length independent on input  $\rightarrow$  called **ICT**
- Torus1 for correct inductance: damped resonant circuit of entire devices
- Broad bandpass filter  $\Rightarrow$  ringing signal, to enlarge sensitivity  $\rightarrow$  called **Turbo-ICT**



# Integrating Current Transformer ICT for short Pulses

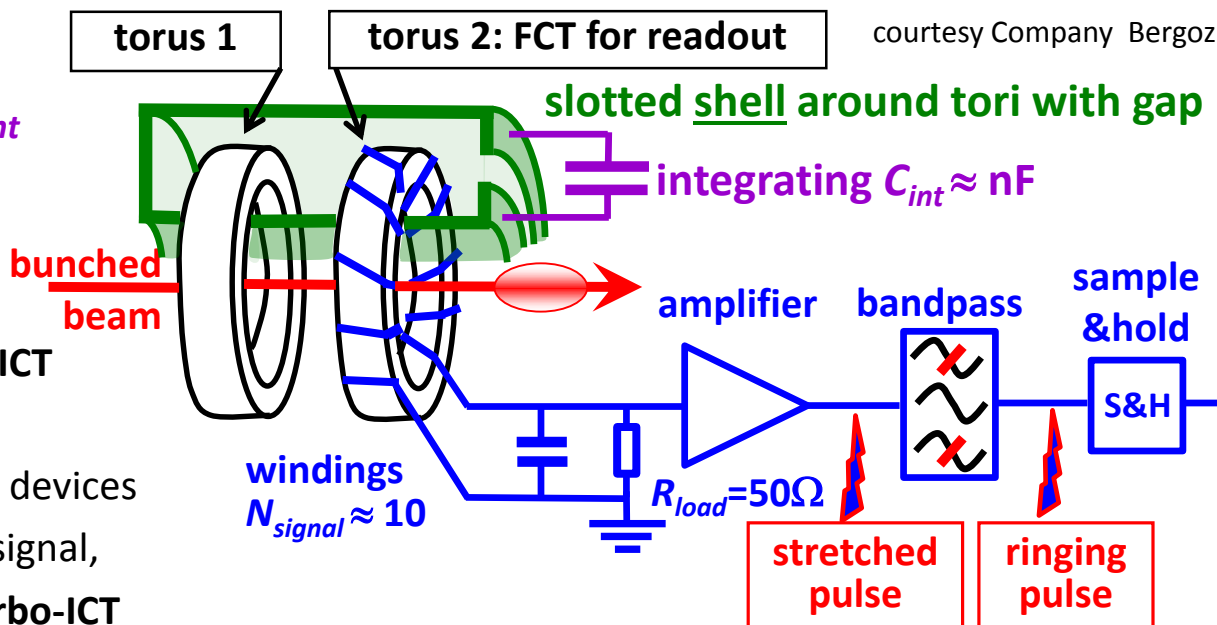
Typical parameter of a Turbo-ICT as used at FELs and Laser Plasma Accelerators:

Tori thickness	$l = 5$ mm respectively
Full scale range	500 fC ... 1 nC
<b>Resolution</b>	<b>10 fC<sub>rms</sub> <math>\leftrightarrow</math> 10<sup>5</sup> e<sup>-</sup> / bunch</b>
Max. pulse repetition	500 ns for single pulses
Dynamic range	80 dB by logarithmic amp.



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 ⇒ **stretched pulse**, length independent on input → called **ICT**
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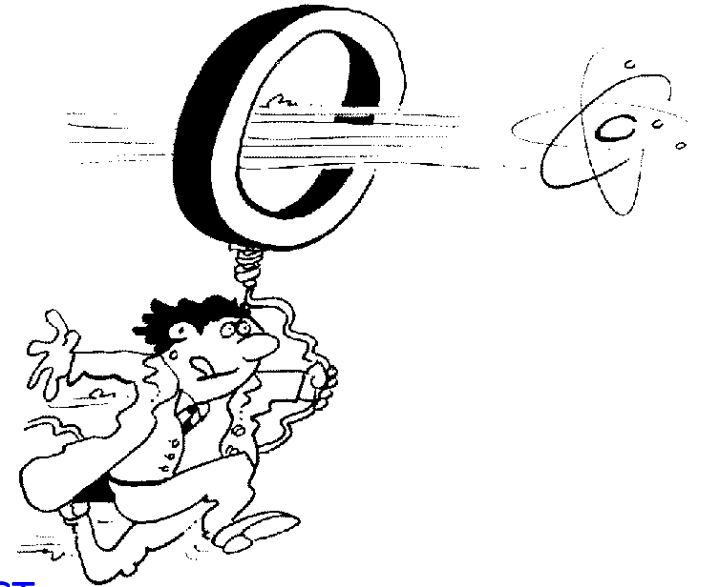


# The Artists View of Transformers

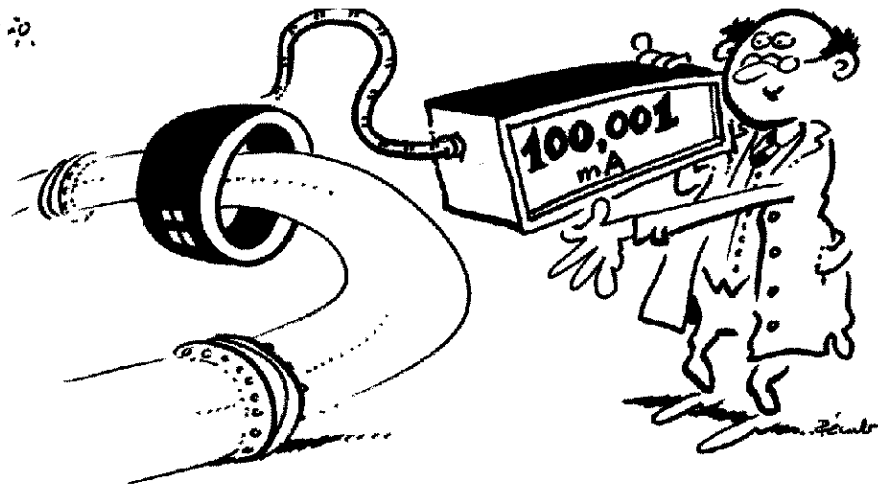
The active transformer ACCT



The Fast Transformer FCT



The dc transformer DCCT



Company Bergoz

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- It is the first check of the accelerator functionality
- It has to be determined in an absolute manner
- Important for transmission measurement and to prevent for beam losses.

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- **Transformers:** Measurement of the beam's **magnetic field**

They are non-destructive. No dependence on beam energy

They have lower detection threshold.

- **Faraday cups:** Measurement of the beam's **electrical charges**

They are destructive. For low energies only

Low currents can be determined.

- **Particle detectors:** Measurement of the particle's **energy loss** in matter

Examples are scintillators, ionization chambers, secondary e<sup>-</sup> emission monitors

Used for low currents at high energies e.g. for slow extraction from a synchrotron.

# Excuse: Energy Loss of Ions in Matter

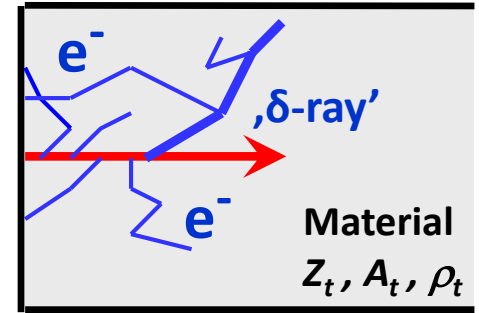
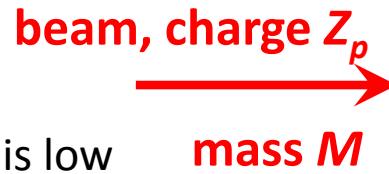
Bethe-Bloch formula:

(simplest formulation)

$$-\frac{dE}{dx} = 4\pi N_A r_e^2 m_e c^2 \cdot \frac{Z_t}{A_t} \rho_t \cdot Z_p^2 \cdot \left(\frac{1}{\beta^2}\right) \left(\frac{1}{2} \ln \frac{2m_e c^2 \beta^2 \gamma^2 \cdot W_{max}}{I^2} - \beta^2\right)$$

Semi-classical approach:

- Projectiles of mass  $M$  collide with free electrons of mass  $m$
- If  $M \gg m$  then the relative energy transfer is low
- ⇒ many collisions required many electrons participate



proportional to target electron density  $n_e = \frac{Z_t}{A_t} \rho_t$

⇒ low straggling for the heavy projectile i.e. 'straight trajectory'

- If projectile velocity  $\beta \approx 1$  low relative energy change of projectile ( $\gamma$  is Lorentz factor)
- $I$  is mean ionization potential including kinematic corrections  $I \approx Z_t \cdot 10 \text{ eV}$  for most metals
- Strong dependence on projectile charge  $Z_p$  as  $\frac{dE}{dx} \propto Z_p^2$

Constants:  $N_A$  Avogadro number,  $r_e$  classical  $e^-$  radius,  $m_e$  electron mass,  $c$  velocity of light

Maximum energy transfer from projectile  $M$  to electron  $m_e$ :  $W_{max} = \frac{2m_e c^2 \beta^2 \gamma^2}{1 + 2\gamma m_e/M + (m_e/M)^2}$



# Excuse: Energy Loss of Ions in Copper

Bethe-Bloch formula:  $-\frac{dE}{dx} = 4\pi N_{Ar} r_e^2 m_e c^2 \cdot \frac{Z_t}{A_t} \rho_t \cdot Z_p^2 \cdot \frac{1}{\beta^2} \left( \frac{1}{2} \ln \frac{2m_e c^2 \beta^2 \gamma^2 \cdot W_{max}}{I^2} - \beta^2 \right)$   
 (simplest formulation)

Range:  $R = \int_0^{E_{max}} \left( \frac{dE}{dx} \right)^{-1} dE$

with approx. scaling  $R \propto E_{max}^{1.75}$

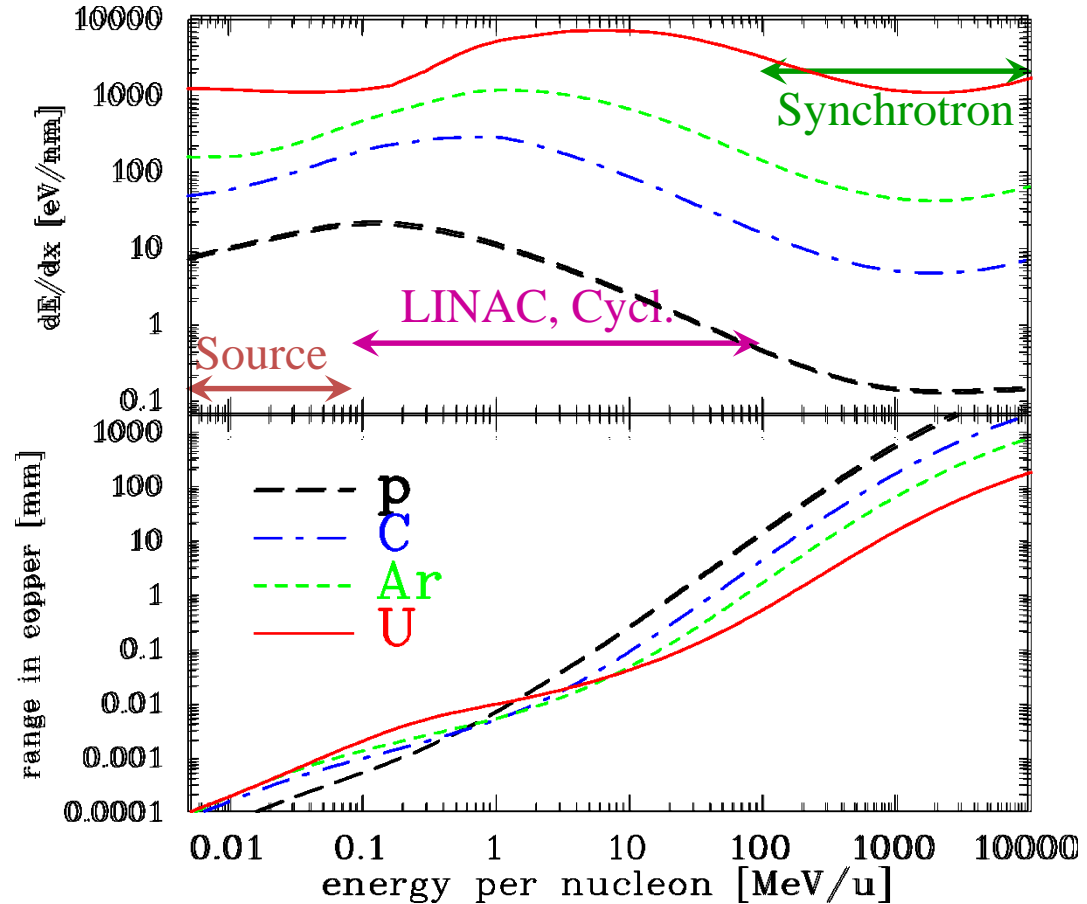
Numerical calculation for **ions**

with semi-empirical model e.g. SRIM

Main modification  $Z_p \rightarrow Z_p^{eff}(E_{kin})$

⇒ **Cups** only for

$E_{kin} < 100 \text{ MeV/u}$  due to  $R < 10 \text{ mm}$



# Excuse: Secondary Electron Emission by Ion Impact

Energy loss of ions in metals close to a surface:

Closed collision with large energy transfer  $\rightarrow$  fast  $e^-$  with  $E_{kin} \gg 100$  eV

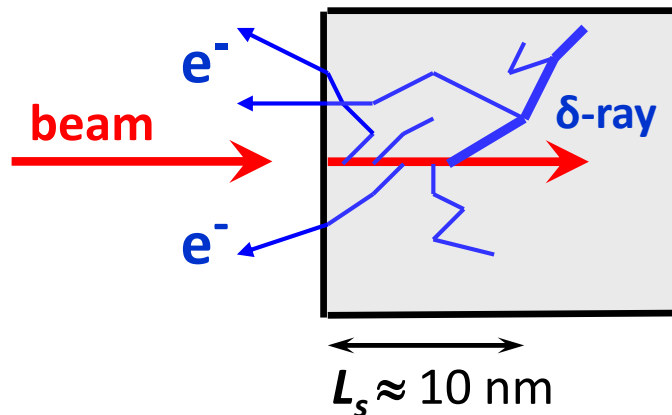
Distant collision with low energy transfer  $\rightarrow$  slow  $e^-$  with  $E_{kin} \leq 10$  eV

$\rightarrow$  'diffusion' & scattering with other  $e^-$ : scattering length  $L_s \approx 1 - 10$  nm

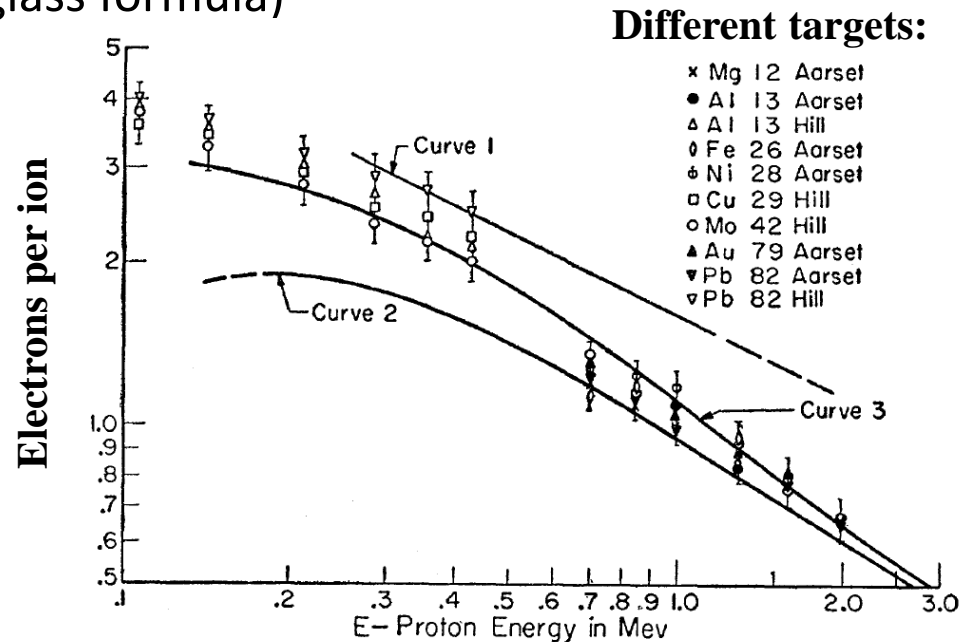
$\rightarrow$  at surface  $\approx 90\%$  probability for escape

Secondary **electron yield** and energy distribution comparable for all metals!

$$\Rightarrow Y = \text{const.} * dE/dx \quad (\text{Sternglass formula})$$



From E.J. Sternglass, Phys. Rev. 108, 1 (1957)



# Excuse: Secondary Electron Emission by Ion Impact

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Closed collision with large energy transfer  $\rightarrow$  fast  $e^-$  with  $E_{kin} \gg 100$  eV

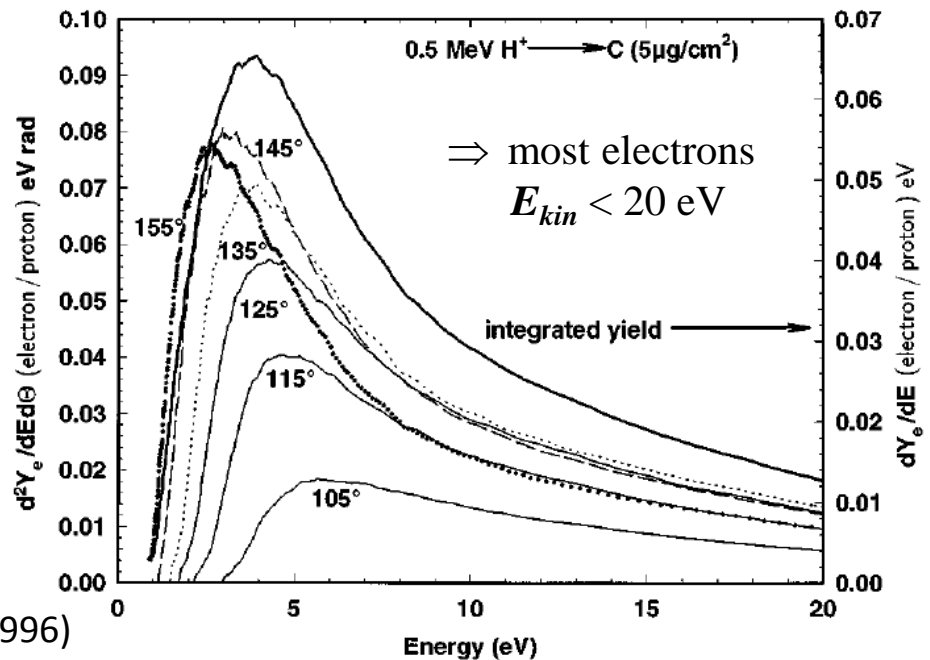
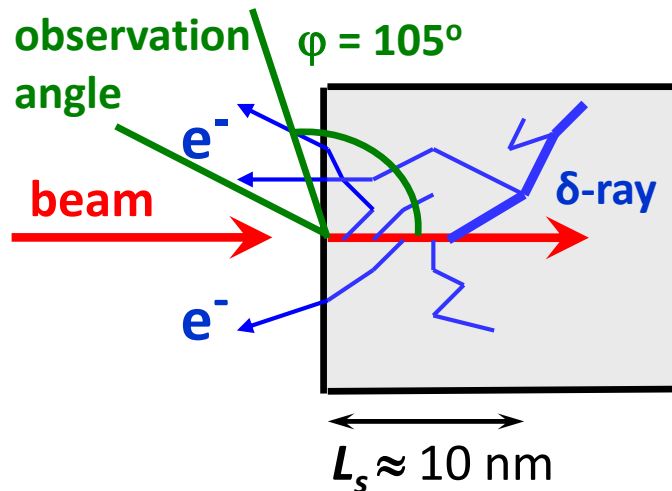
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Secondary **electron yield** and energy distribution comparable for all metals!

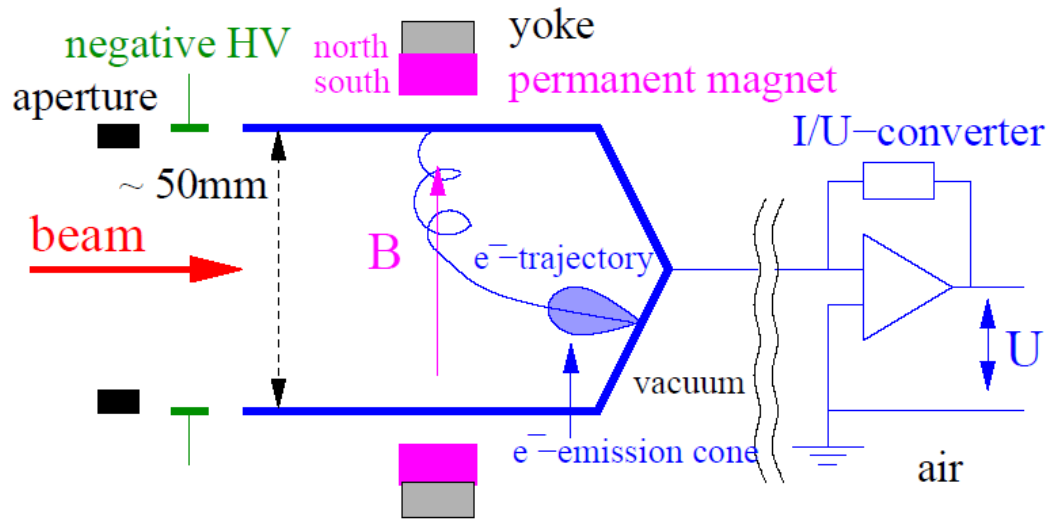
$$\Rightarrow Y = \text{const.} * dE/dx \quad (\text{Sternglass formula})$$



From C.G. Drexler, R.D. DuBois, Phys. Rev. A 53, 1630 (1996)

# Faraday Cups for Beam Charge Measurement

The beam particles are collected inside a metal cup  
 ⇒ The beam's charge are recorded as a function of time.



Currents down to 10 pA with bandwidth of 100 Hz!

## Magnetic field:

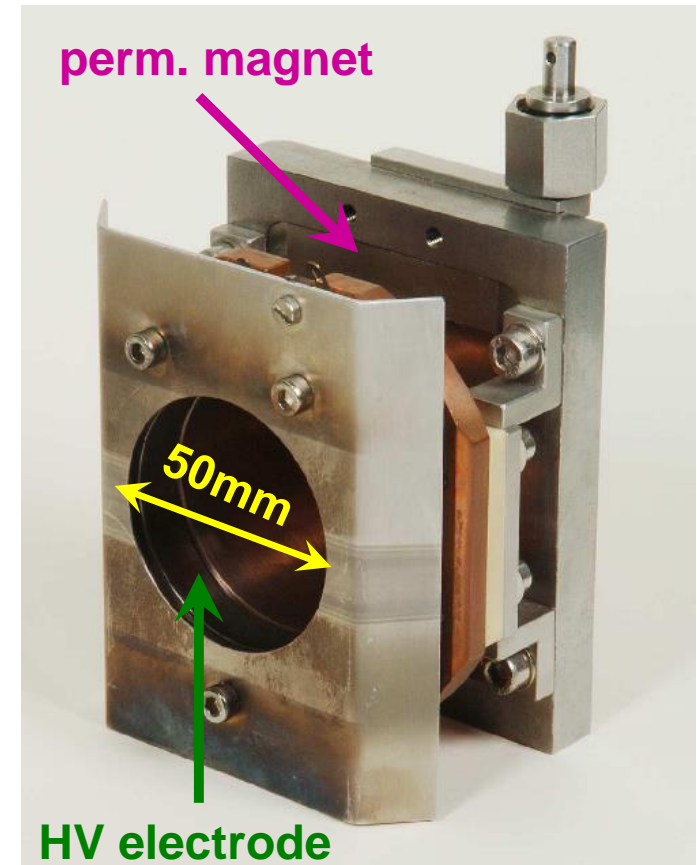
To prevent for secondary electrons leaving the cup

*and/or*

## Electric field:

Potential barrier at the cup entrance.

The cup is moved in the beam pass → destructive device



# Realization of a Faraday Cup at GSI LINAC

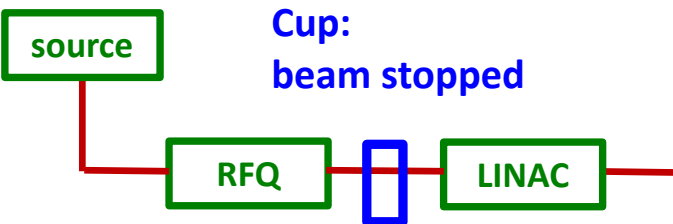
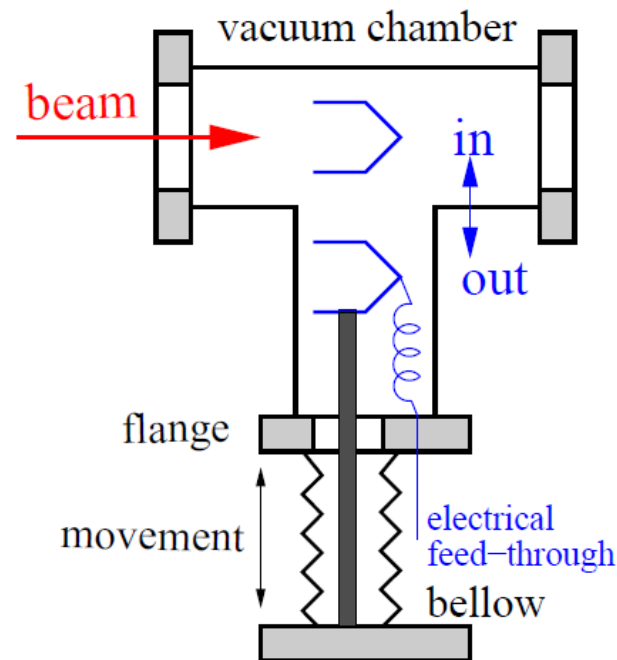
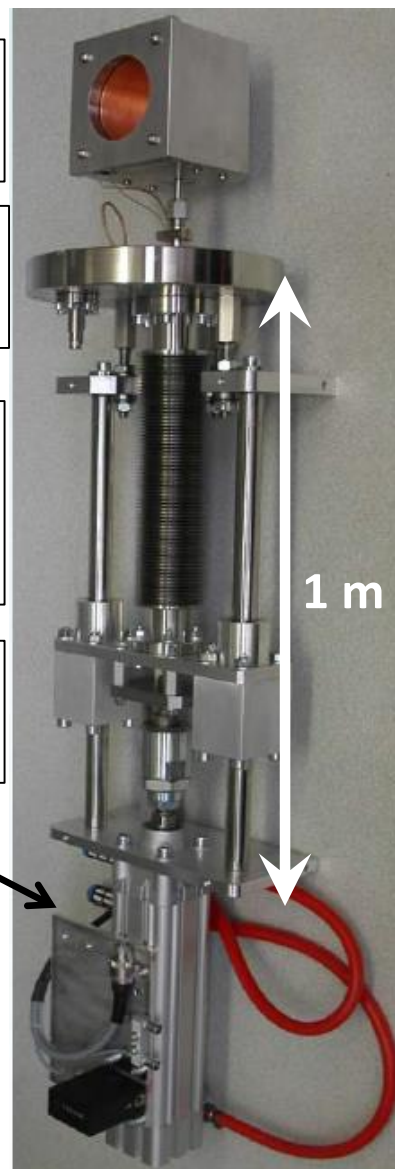
The Cup is moved into the beam pass.

Faraday Cup  
Ø60 mm

vacuum flange  
here Ø150 mm

bellow  
compression  
for movement

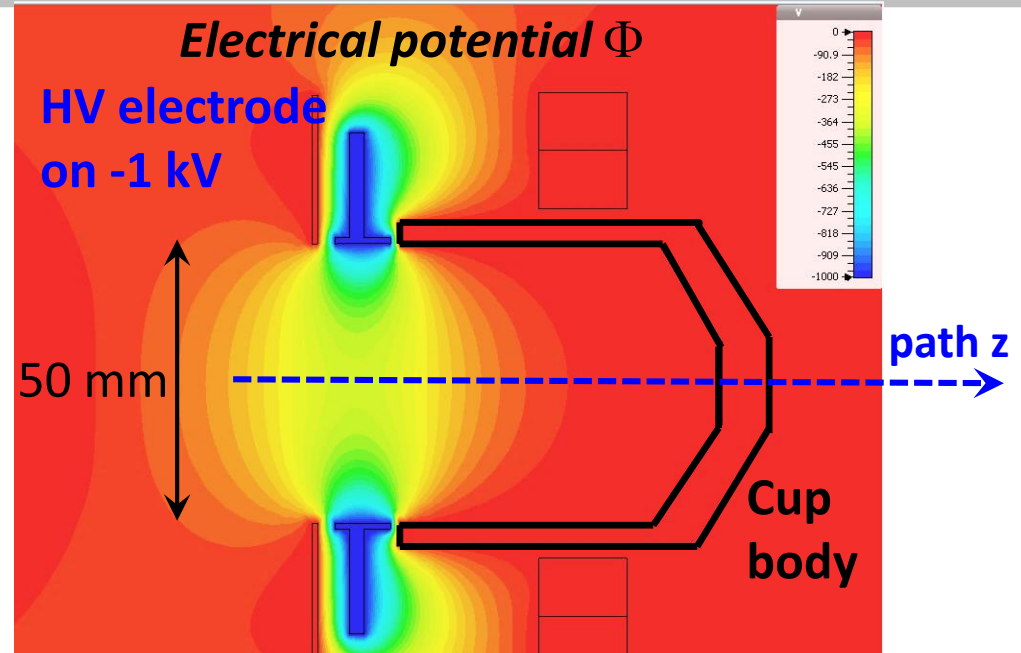
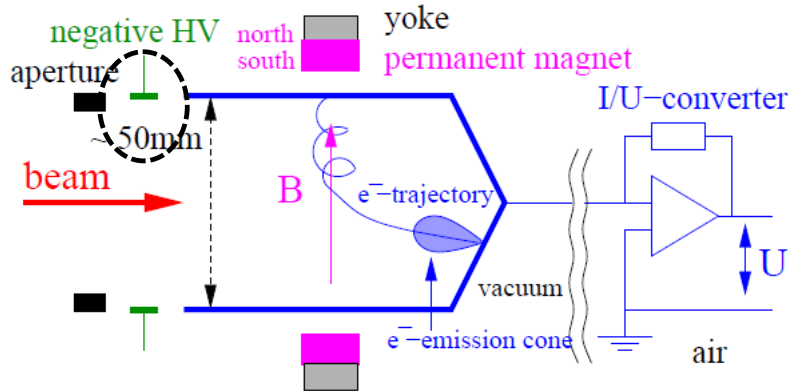
pneumatic  
drive



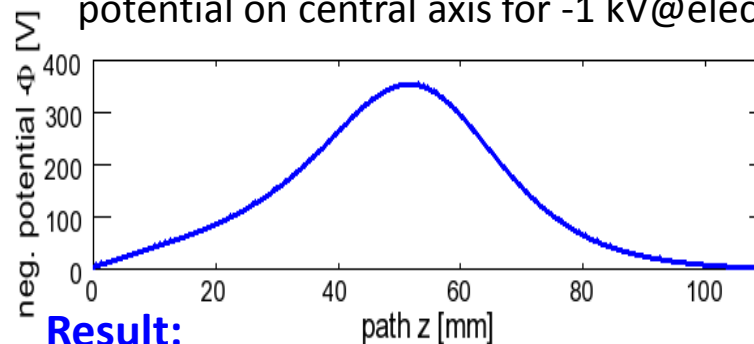
Cup:  
beam stopped

# Secondary Electron Suppression: Electric Field

A ring shaped electrode is used at the entrance of Faraday Cup:  
 Typical voltage 100 to 1000 V



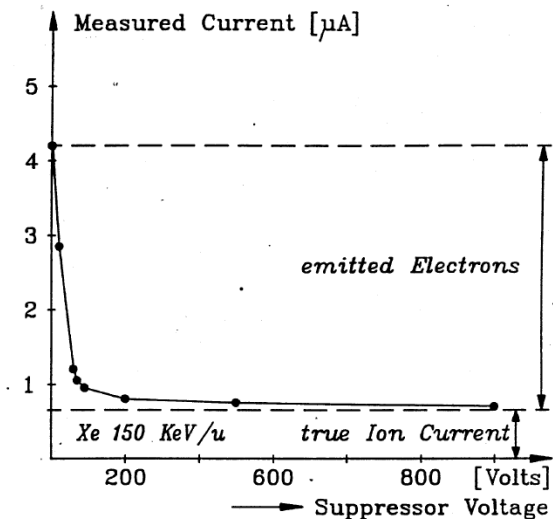
potential on central axis for -1 kV@electrode



**Result:**

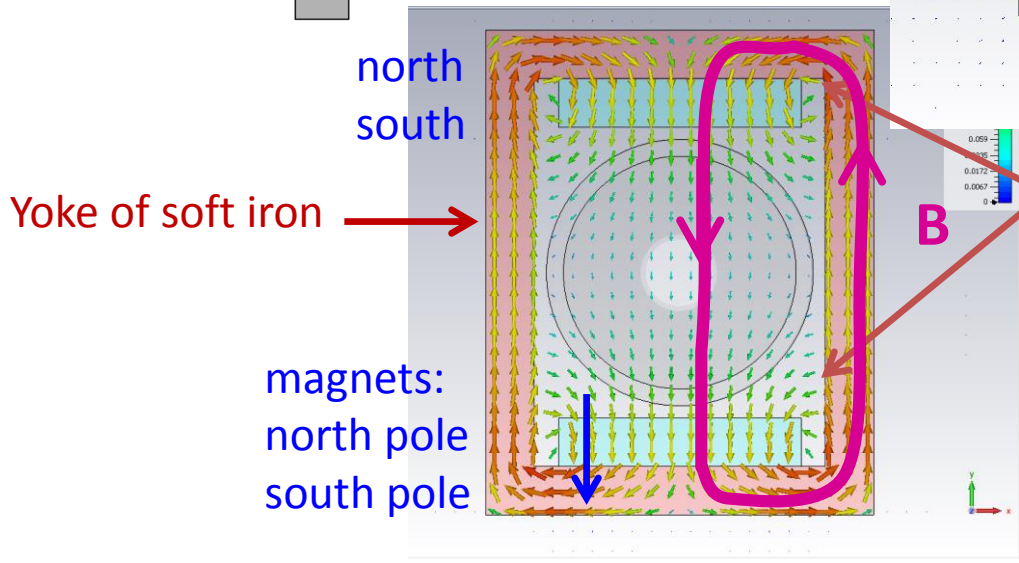
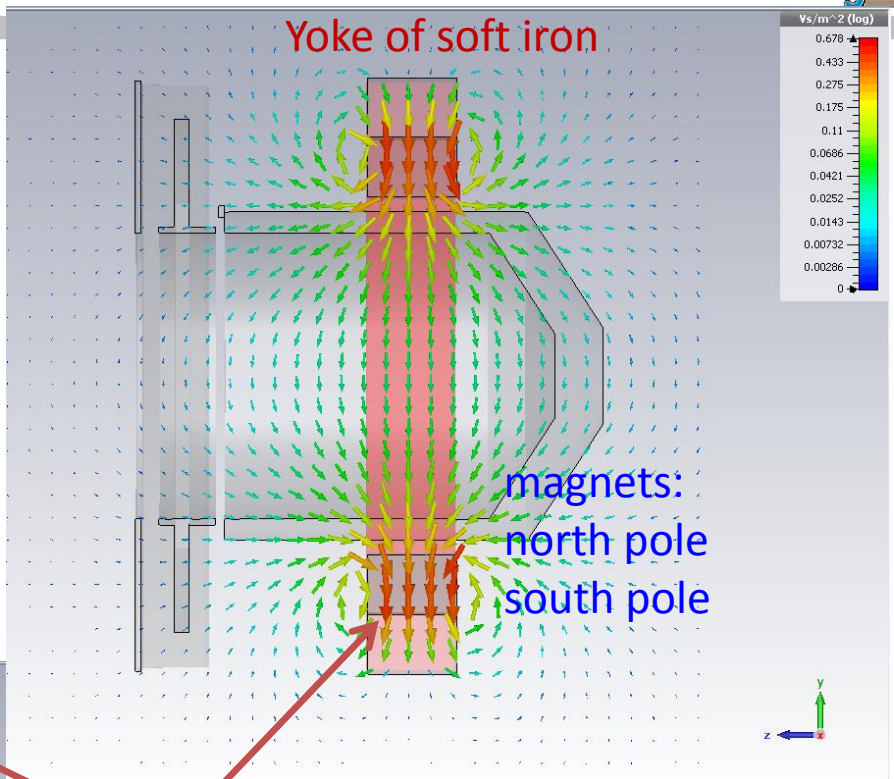
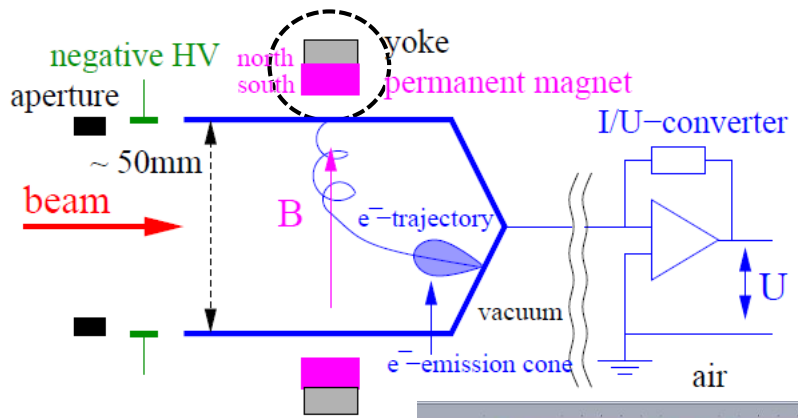
here: potential at center  $\approx 35\%$  of applied voltage

Courtesy of J. Latzko, GSI

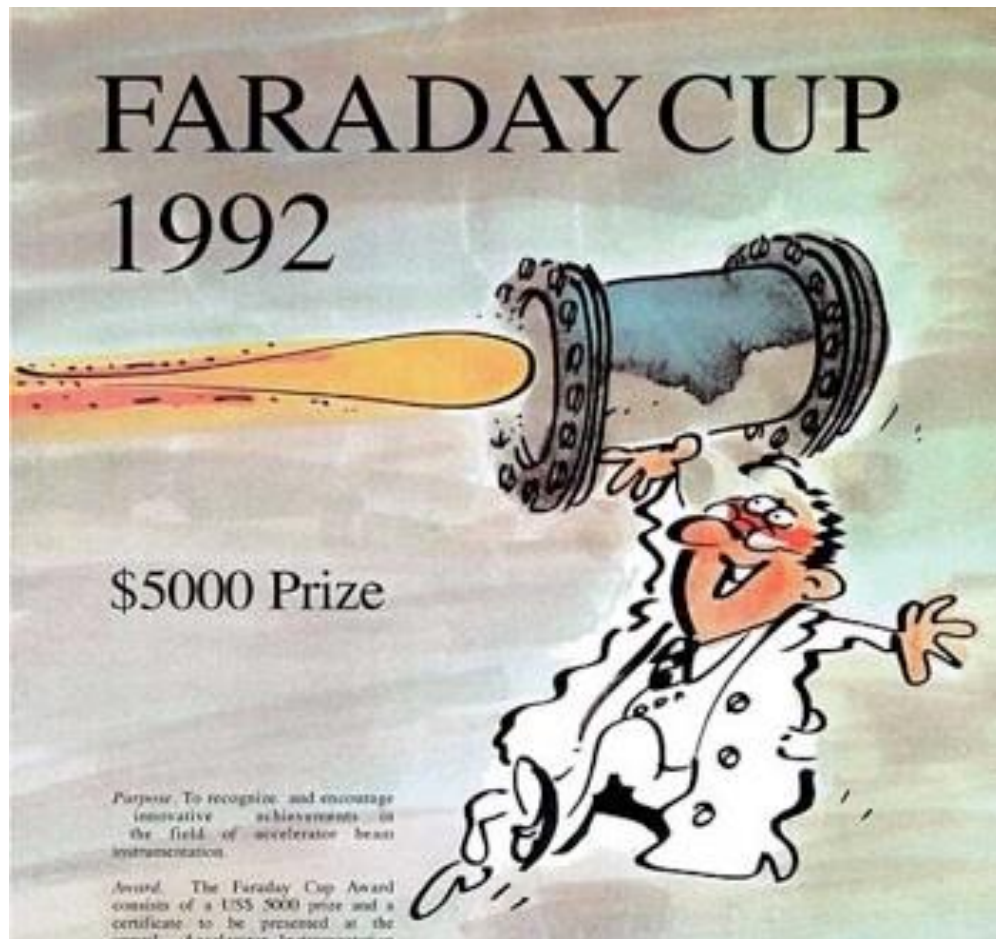


# Secondary Electron Suppression: Magnetic Field

Co-Sm permanent magnets within the yoke and the calculated magnetic field lines.  
 The central field strength is  $B \approx 0.1$  T.



Courtesy of J. Latzko, GSI

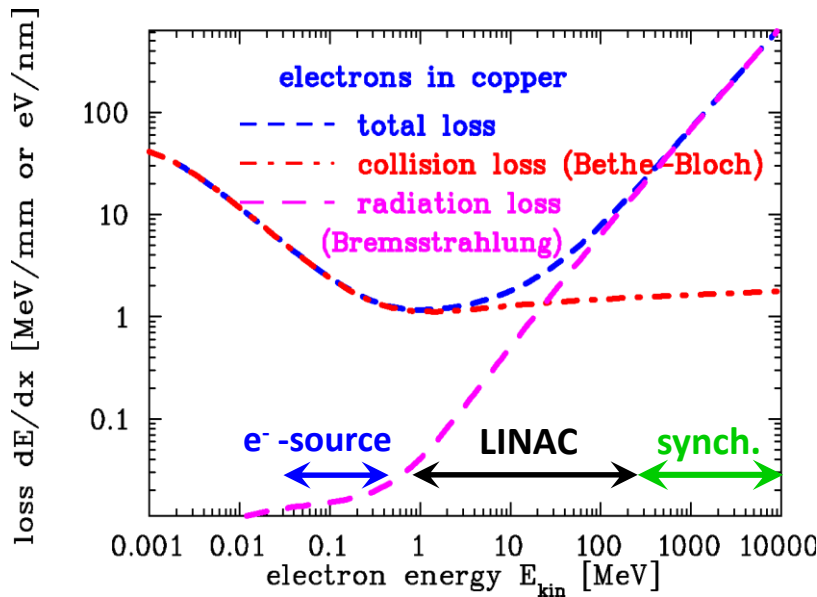


Company Bergoz



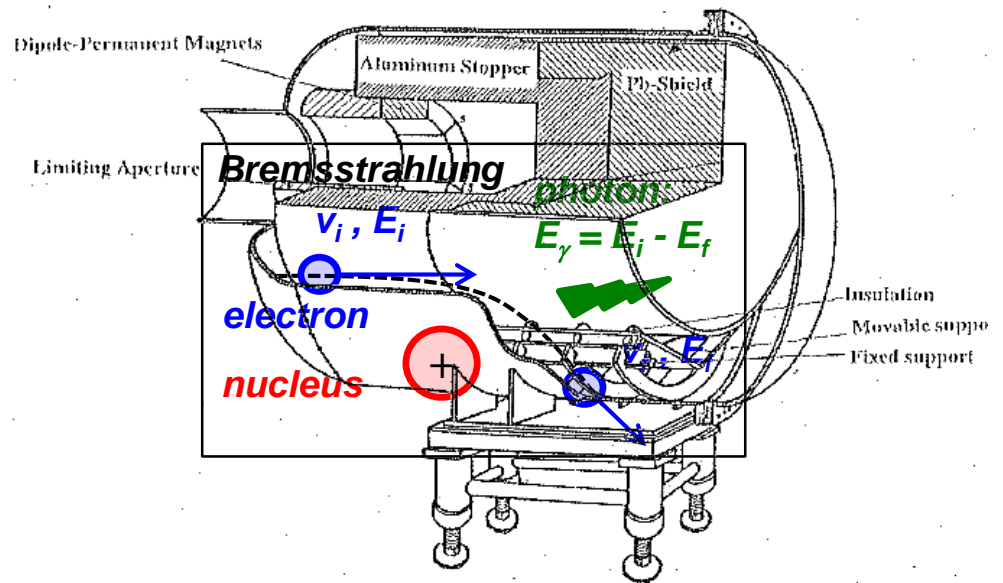
# Energy Loss of Electrons in Copper & Faraday Cups of $e^-$

Collisional loss by Bethe-Bloch formula  $dE/dx|_{col} \propto f(E_{kin}) \cdot Z_t$  is valid for all charged particles. However, radiation loss  $dE/dx|_{rad}$  by Bremsstrahlung (i.e.  $\gamma$ -rays of some MeV) dominates for energies above  $E_{kin} > 10$  MeV with the scaling  $dE/dx|_{rad} \propto E_{kin} \cdot Z_t^2$ . Moreover,  $e^-$  shows much larger longitudinal and transverse straggling.



Minimum of Bethe-Bloch  $dE/dx|_{col}$  roughly at  $E_{kin} \approx m_0 c^2 = 511$  keV (rest mass)  
 $\Leftrightarrow \beta \approx 90\%$  and  $\gamma = \frac{1}{\sqrt{1-\beta^2}} \approx 2$

Example of a Faraday cup for 60 MeV Electrons

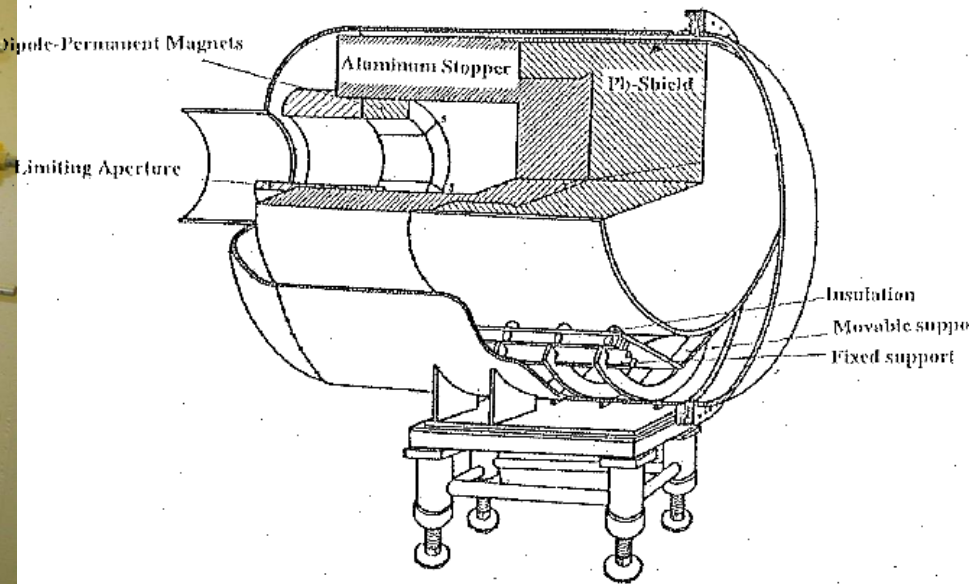
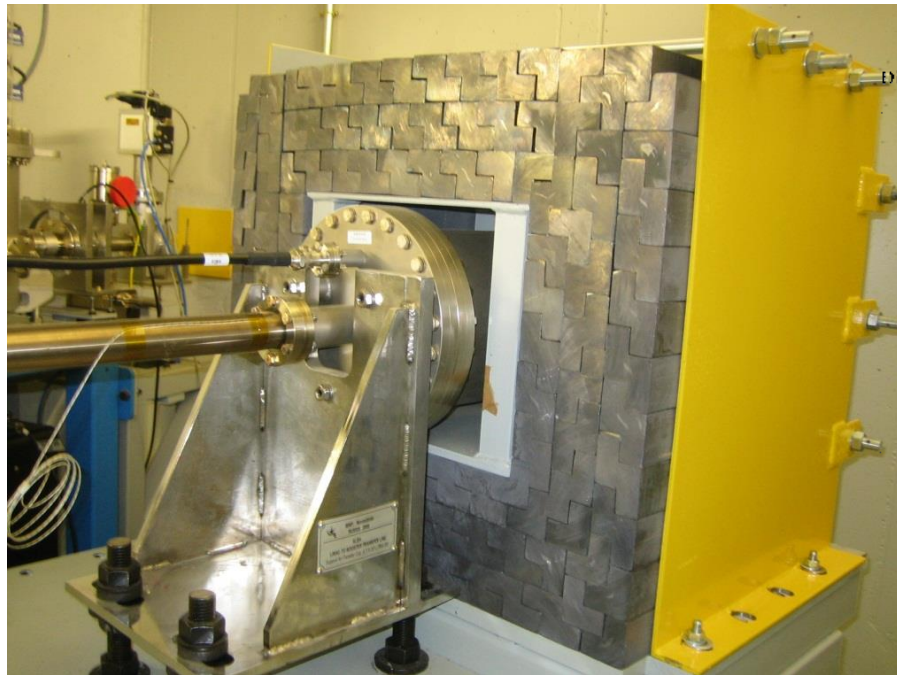


**Al stopper:** Stopping of  $e^-$  gently in low-Z material  
**Pb-shield:** Absorption of Bremsstrahlung- $\gamma$   
 $\Rightarrow$  Used as beam dump

# Energy Loss of Electrons in Copper & Faraday Cups of $e^-$

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Example of a Faraday cup for 60 MeV Electrons



**Al stopper:** Stopping of  $e^-$  gently in low-Z material

**Pb-shield:** Absorption of Bremsstrahlungs- $\gamma$   
 $\Rightarrow$  Used as beam dump

Faraday Cup at ALBA used as beam dump

From U. Iriso (ALBA)

The beam current is the basic quantity of the beam.

- It is the first check of the accelerator functionality
- It has to be determined in an absolute manner
- Important for transmission measurement and to prevent for beam losses.

## Different devices are used:

- **Transformers:** Measurement of the beam's **magnetic field**

They are non-destructive. No dependence on beam energy

They have lower detection threshold.

- **Faraday cups:** Measurement of the beam's **electrical charges**

They are destructive. For low energies only

Low currents can be determined.

- **Particle detectors:** Measurement of the particle's **energy loss** in matter

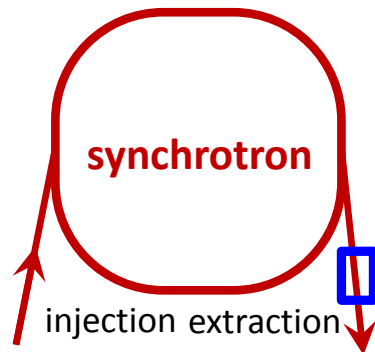
Examples are scintillators, ionization chambers, secondary e<sup>-</sup> emission monitors

Used for low currents at high energies e.g. for slow extraction from a synchrotron.

# Low Current Measurement for slow Extraction

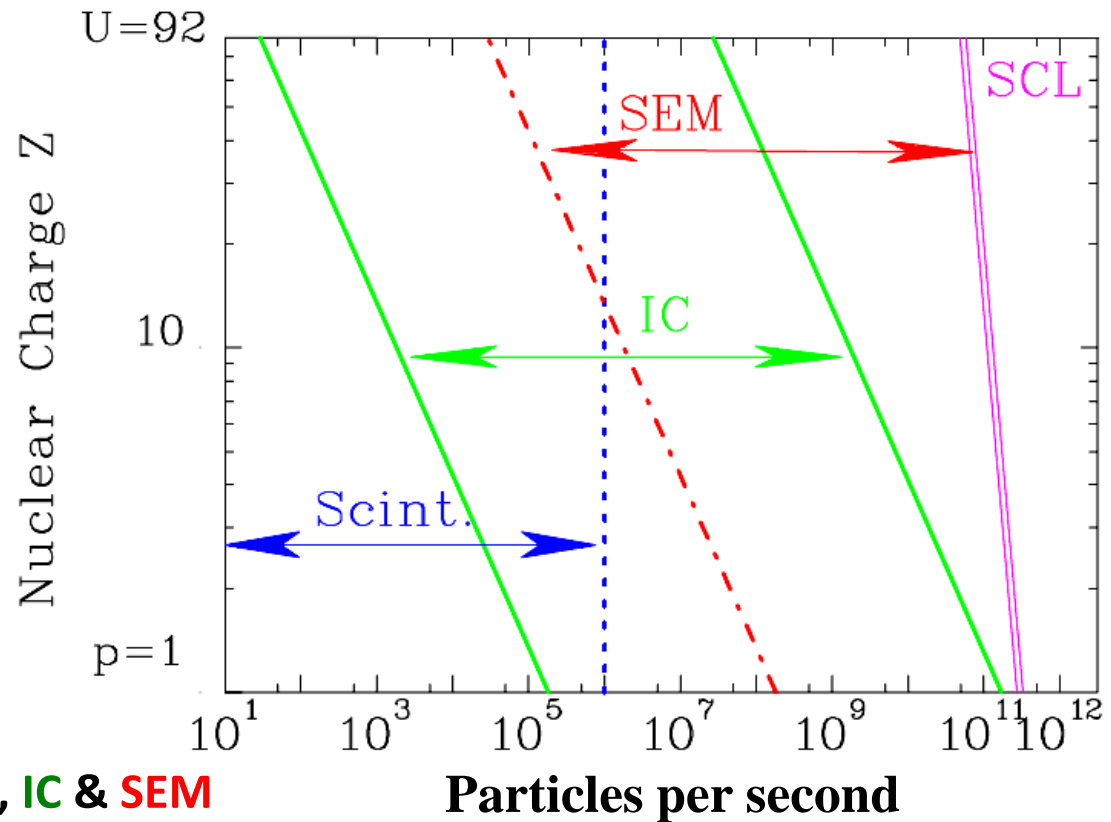
Slow extraction from synchrotron: lower current compared to LINAC, but higher energies and larger range  $R \gg 1$  cm.

- **Particle counting:**  
max:  $r \approx 10^6$  1/s
- **Energy loss in gas (IC):**  
min:  $I_{sec} \approx 1$  pA  
max:  $I_{sec} \approx 1$   $\mu$ A
- **Sec. e- emission:**  
min:  $I_{sec} \approx 1$  pA
- **Max. synch. filling:**  
Space Charge Limit (SCL).



Scint., IC & SEM

Particle detector technologies for ions of 1 GeV/u,  $A = 1$  cm<sup>2</sup>:



# Example of Scintillator Counter

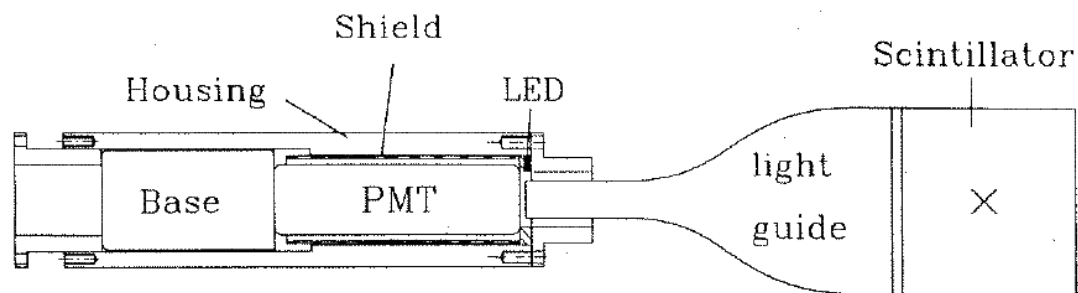
**Example:** Plastic Scintillator i.e. organic fluorescence molecules in a plastic matrix

Here: BC 400 (emission  $\lambda_{max} = 420$  nm, pulse width  $\approx 3$  ns + cable dispersion, size )

**Advantage:** any mechanical form, cheap, blue wave length, fast decay time

**Disadvantage:** not radiation hard

**Particle counting:** Photomultiplier  $\rightarrow$  discriminator  $\rightarrow$  scalar  $\rightarrow$  computer



**1" Photomultiplier**

gain:  $10^6$

rise time 1.9 ns

max. **average** count rate  $3 \cdot 10^6$  1/s

**BC400 Scintillator**

75 x 75 mm<sup>2</sup>

1 mm thickness

# Low Current Measurement: Particle Detectors

Electronic **solid state amplifier** have finite noise contribution

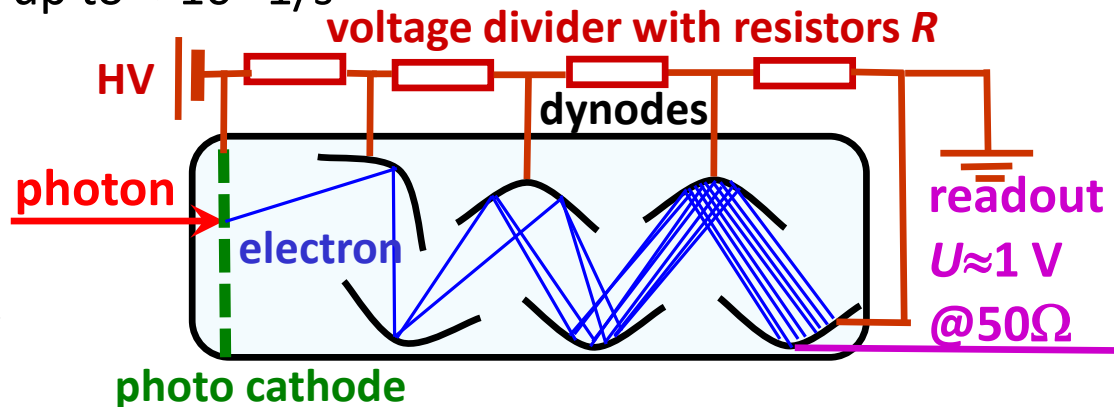
Theoretical limit:  $U_{eff} = \sqrt{4k_B \cdot R \cdot \Delta f \cdot T}$

Signal-to-Noise ratio limits the minimal detectable current

**Idea:** Amplification of single particles with photo-multiplier, sec. e<sup>-</sup> multiplier or MCPs  
and particle counting typically up to  $\approx 10^6$  1/s

## Scheme of a photo-multiplier:

- Photon hits photo cathode
- Secondary electrons are acc. to next dynode  $\Delta U \approx 100$  V
- Typ. 10 dynodes  $\Rightarrow 10^6$  fold amplification



**Advantage:** no thermal noise  
due to electro static acceleration  
Typical 1 V signal output

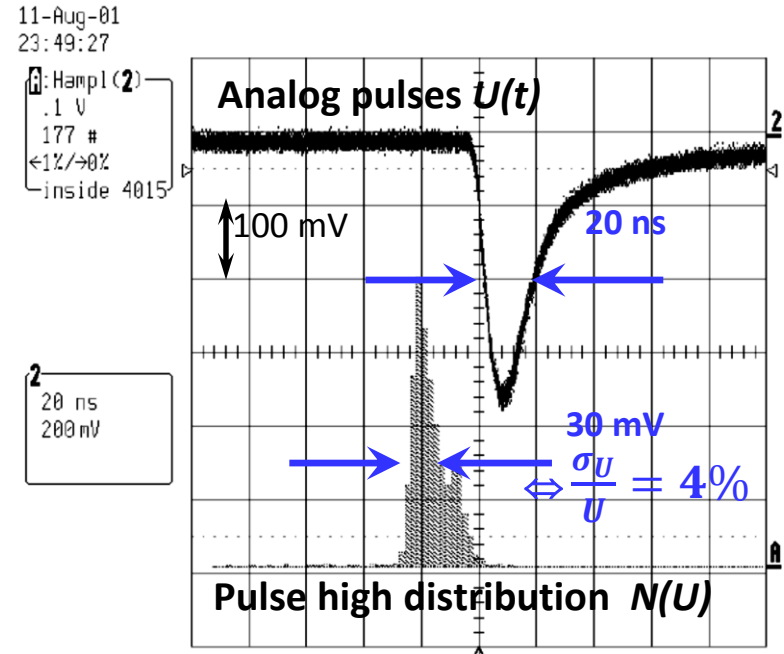


# Properties of a good Scintillator

## Properties of a good scintillator:

- Light output linear to energy loss
- Fast decay time → high rate
- No self-absorption
- Wave length of fluorescence  
 $350 \text{ nm} < \lambda < 500 \text{ nm}$
- Index of refractivity  $n \approx 1.5$   
→ light-guide
- Radiation hardness  
e.g. Ce-activated inorganic  
are much more radiation hard.

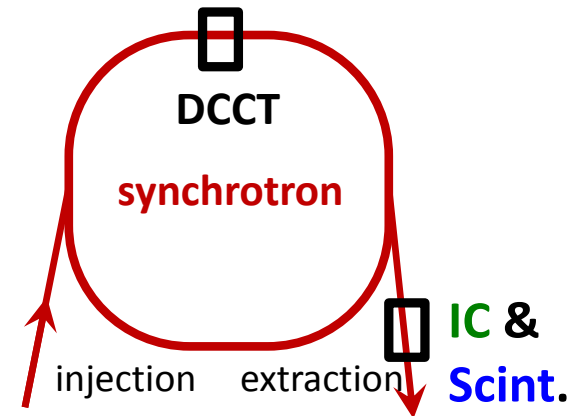
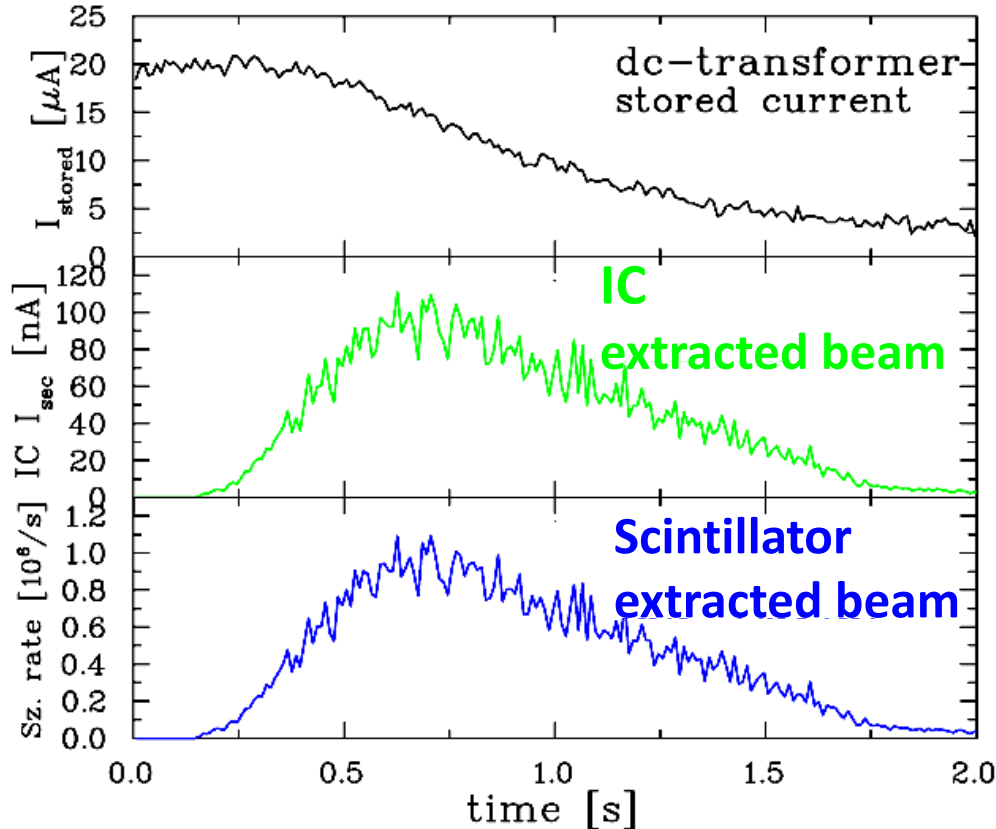
Analog pulses from a plastic sc. with a low current 300 MeV/u Kr beam.



The scaling is 20 ns/div and 100 mV/div.

## Slow extraction from a synchrotron delivers countable currents

**Example:** Comparison for different detector types:

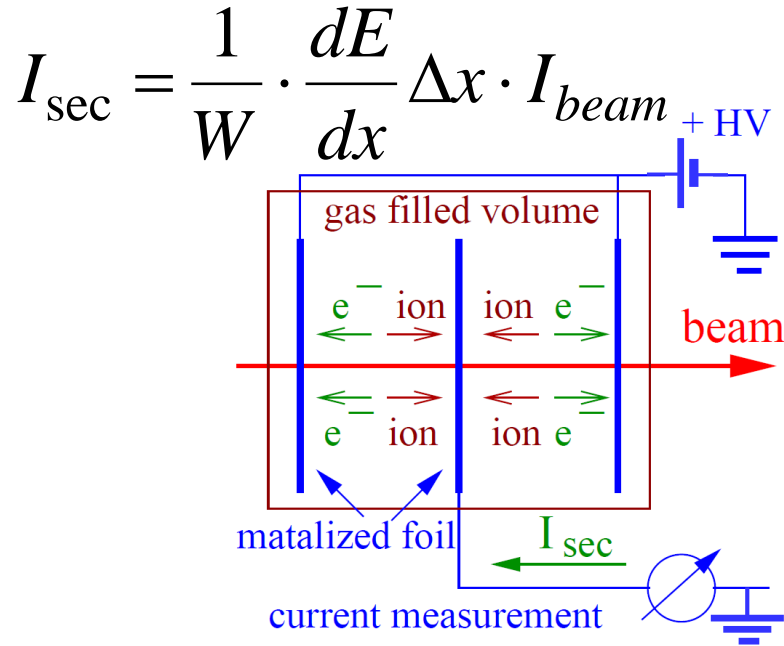


Parameters: dc-transformer inside the synch., ionization chamber and scintillator for a 250 MeV/u  $\text{Pb}^{67+}$  beam with a total amount of  $10^6$  particles.

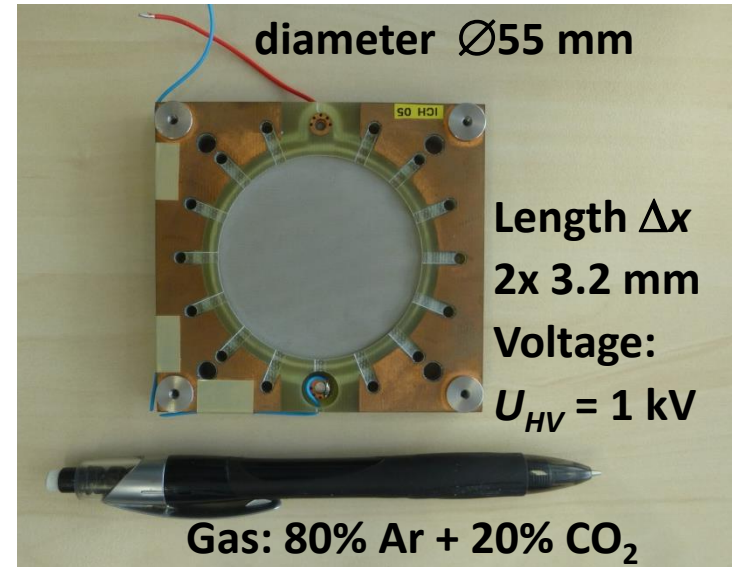


# Ionization Chamber (IC): Electron Ion Pairs

Energy loss of charged particles in gases → electron-ion pairs → low current meas.



Example: GSI type:



*W-value*

is the average energy for one  $e^-$ -ion pair:

Gas	Ionization Pot.	W-value
He	24.5 eV	42.7 eV
N <sub>2</sub>	15.5 eV	36.4 eV
O <sub>2</sub>	12.5 eV	32.2 eV
Ar	15.7 eV	26.3 eV
CO <sub>2</sub>	13.7 eV	33.0 eV

GSI realization:

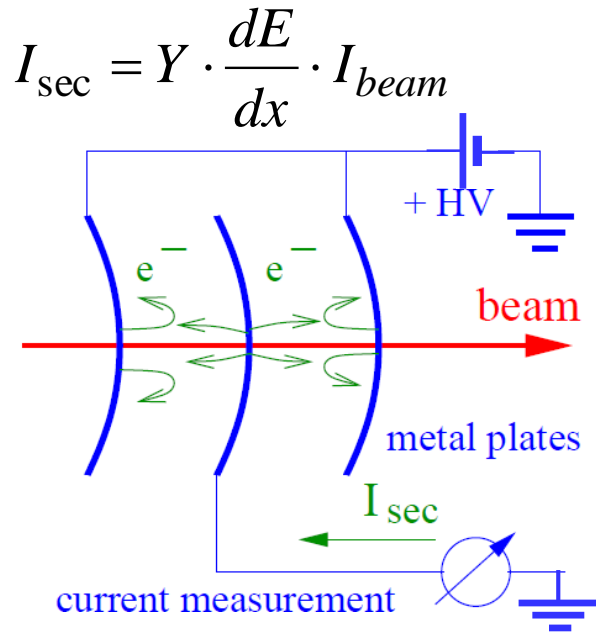
- Energy calculation  $dE/dx$  with SRIM or LISE
- Current measurement via current-to-frequency converter IFC

# Secondary Electron Monitor (SEM): Electrons from Surface

For higher intensities SEMs are used.

Due to the energy loss, secondary  $e^-$  are emitted from a metal surface.

The amount of secondary  $e^-$  is proportional to the energy loss



Example: GSI SEM type:

Material	Pure Al (99.5%)
# electrodes	3
Active surface	80 x 80 mm <sup>2</sup>
Distance between electrodes	5 mm
Applied voltage	+ 100 V
CO <sub>2</sub>	13.7 eV

**Advantage for Al:** good mechanical properties.

**Disadvantage:** Surface effect!

e.g. decrease of yield  $Y$  due to radiation

⇒ calibration versus IC required to reach 5%.

It is a **surface** effect:

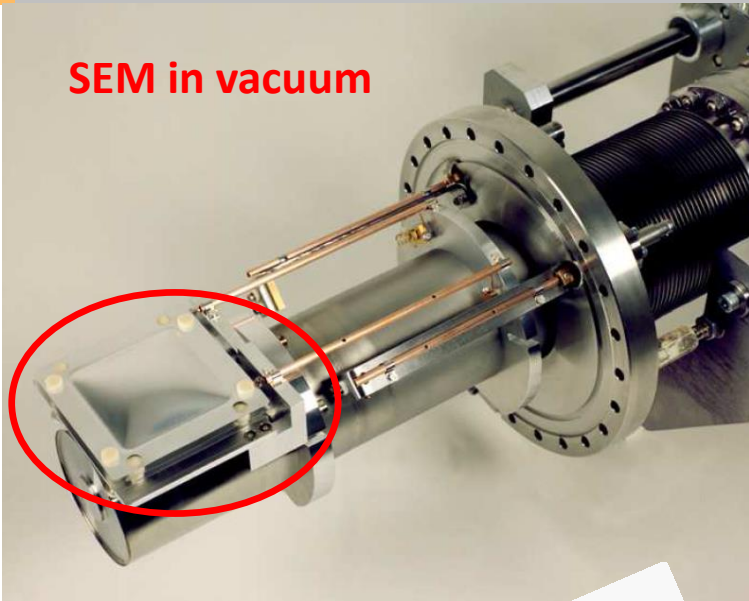
→ Sensitive to cleaning procedure

→ Possible surface modification by radiation

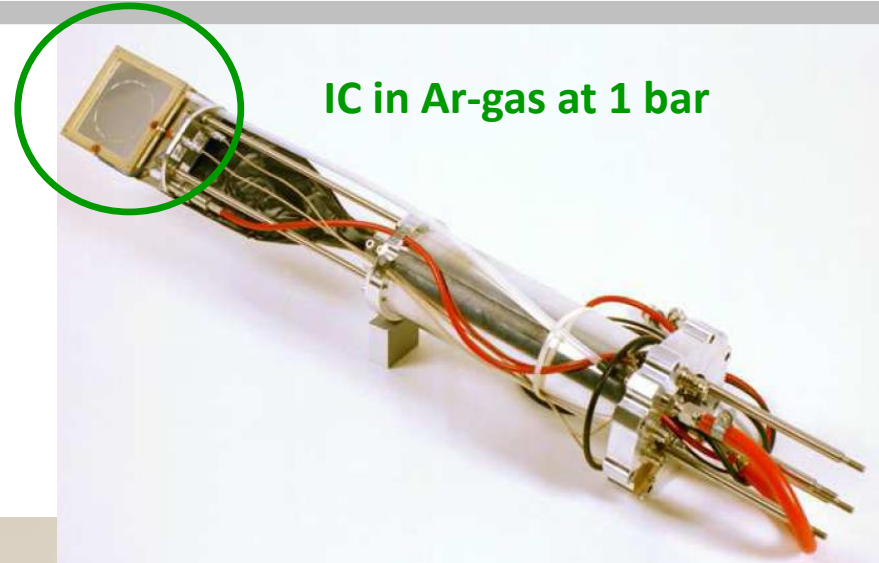
Sometimes they are installed permanently in front of an experiment.

# GSI Installation for SEM, IC and Scintillator

SEM in vacuum



IC in Ar-gas at 1 bar



beam

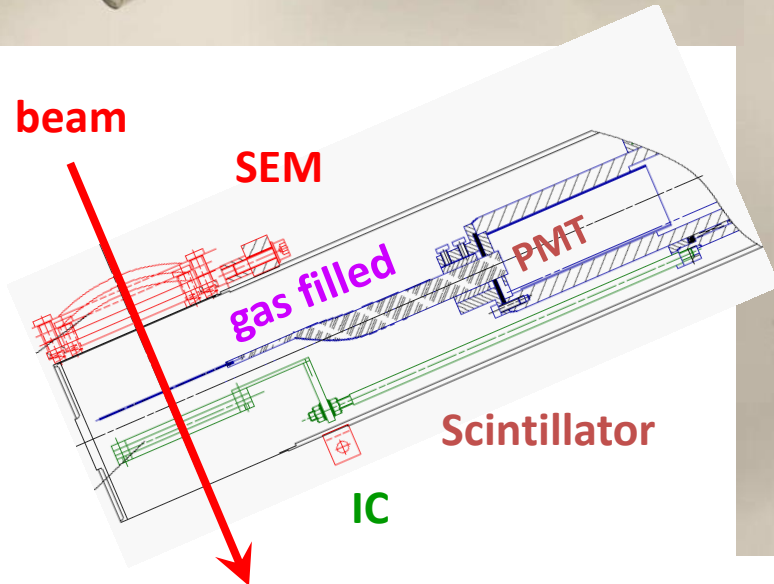
SEM

gas filled

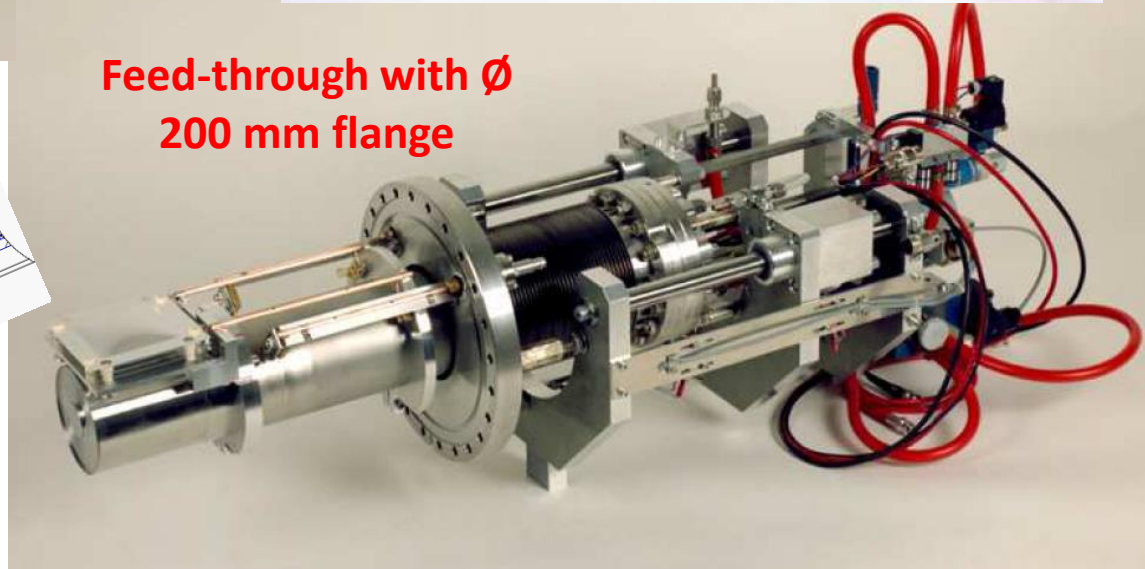
PMT

Scintillator

IC

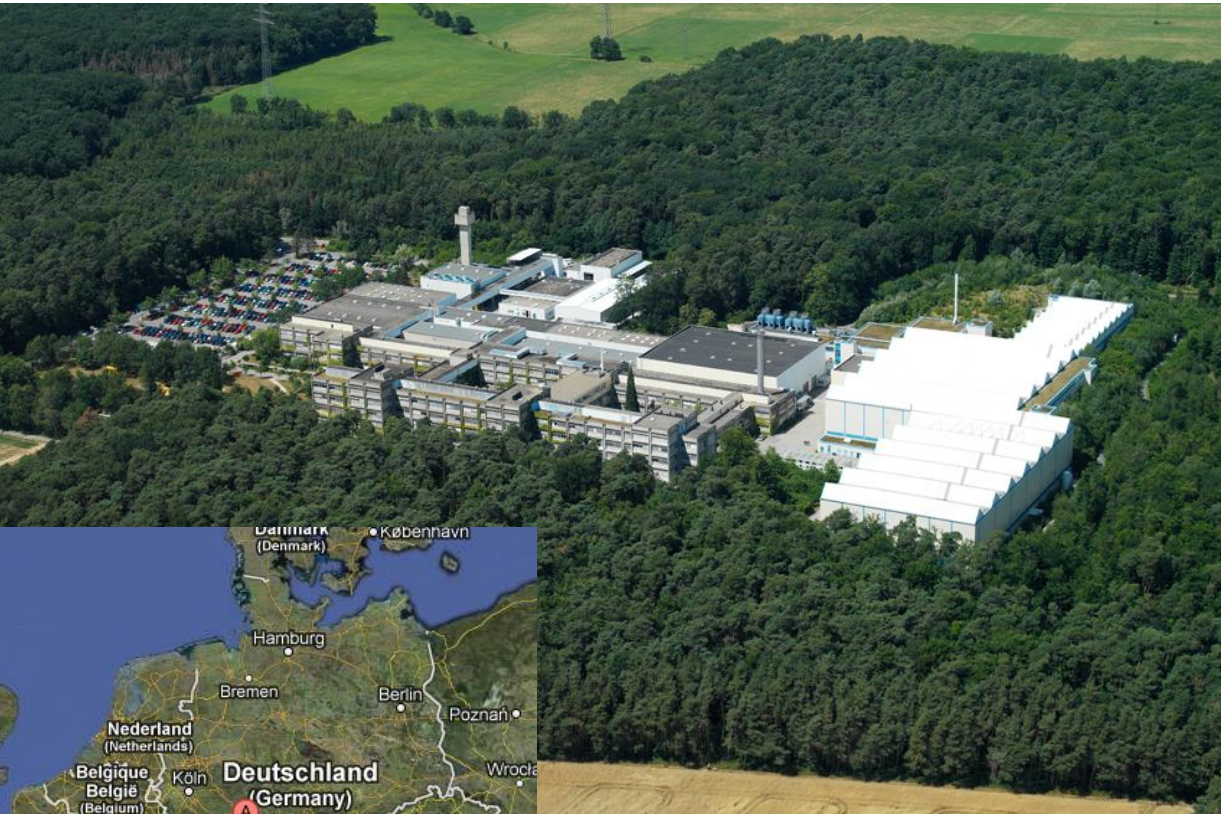


Feed-through with  $\varnothing$  200 mm flange



P. Forck et al., DIPAC'97

## German national heavy ion accelerator facility in Darmstadt



### Accelerators:

Acceleration of all ions

LINAC: up to 15 MeV/u

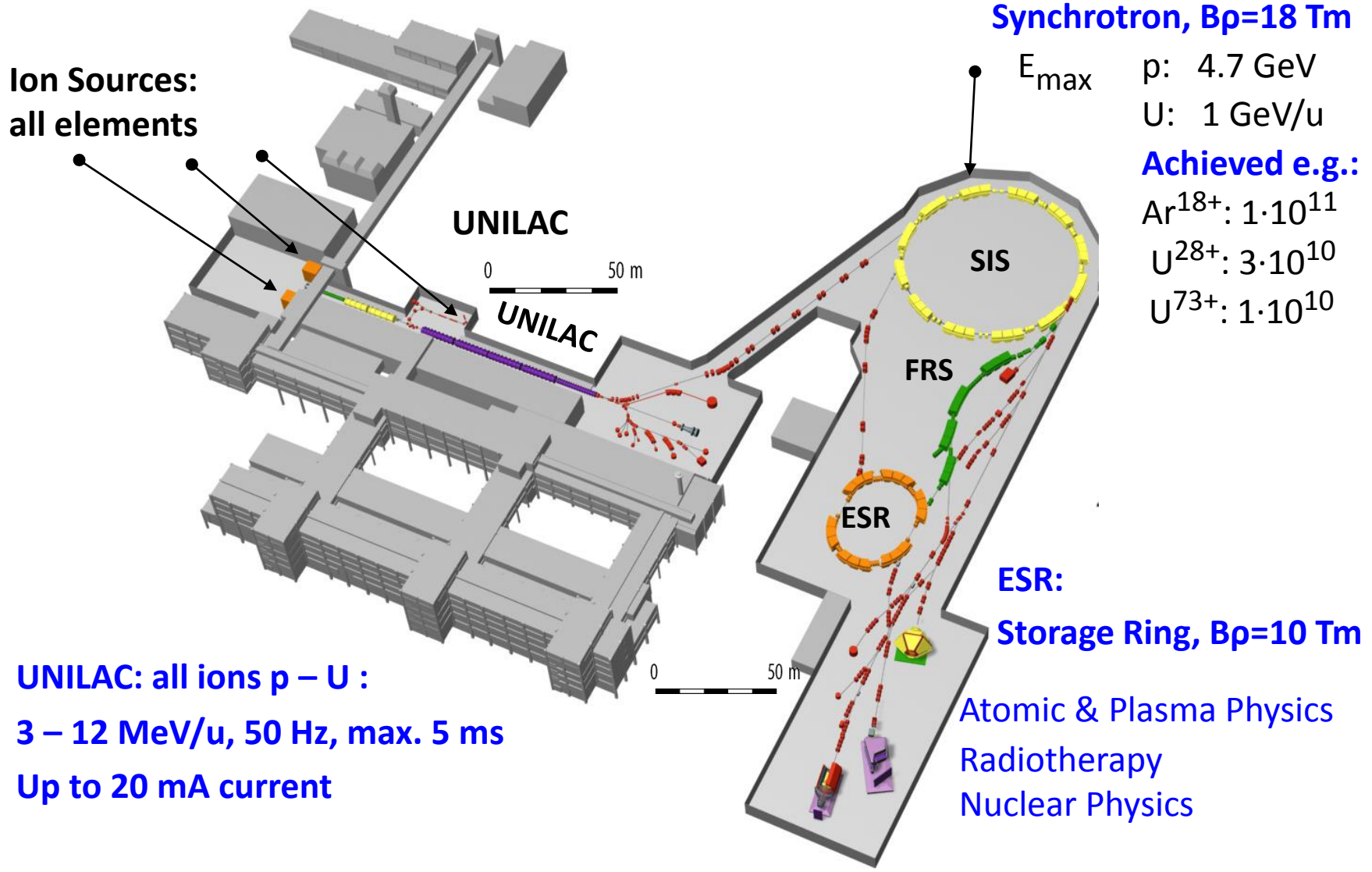
Synchrotron: up to 2 GeV/u

### Research area:

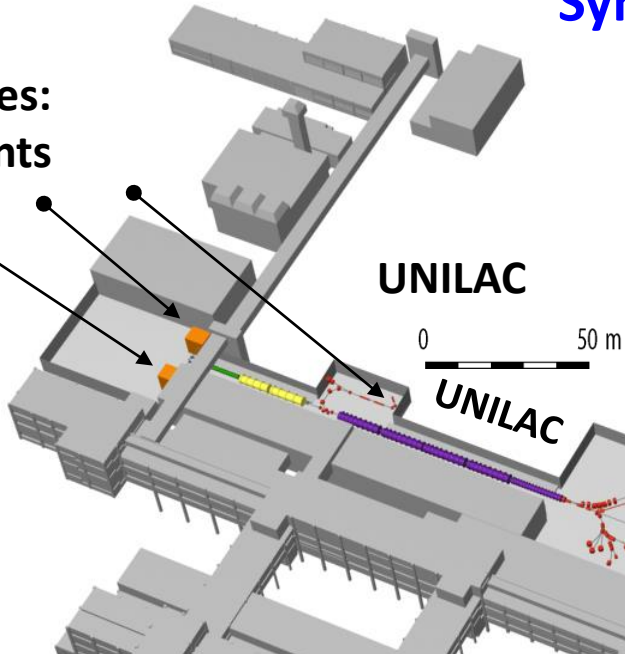
- Nuclear physics  $\approx 60\%$
- Atomic physics  $\approx 20\%$
- Bio physics (e.g. cell damage)  
incl. cancer therapy  $\approx 10\%$
- Material research  $\approx 10\%$

**Extension by international FAIR facility**

**GSI is one of 18 German large scale research centers.**

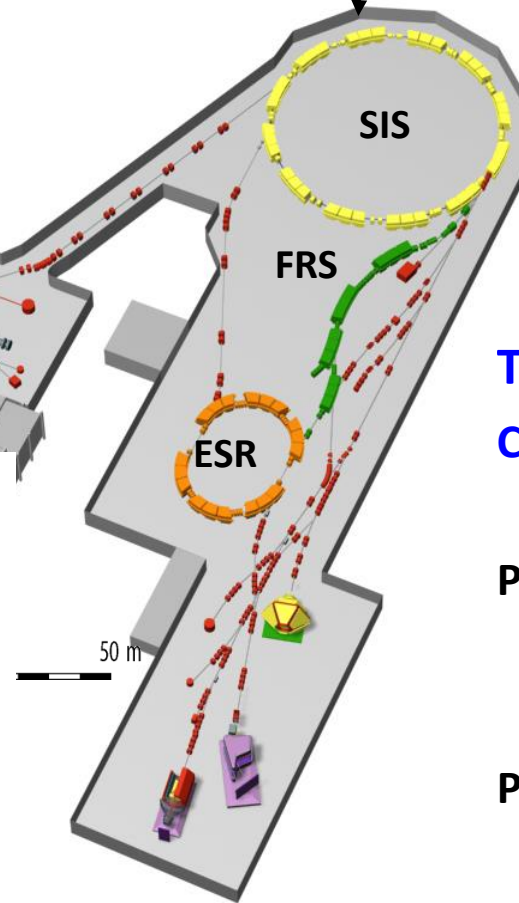


**Ion Sources:**  
all elements

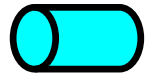


**Synchrotron:** **Current:** 2 DCCT, 1 ACCT, 1 FCT  
**Profile:** 1 SEM-Grid, 1 IPM, 1 Screen  
**Position:** 16 BPM  
**Tune, mom. spread:** 1 Exciter + BPM  
 1 Schottky

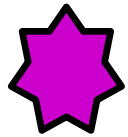
**LINAC:**  
**Current:** 52 transformers, 30 Faraday-Cups  
**Profile:** 81 SEM-Grids, 6 BIF  
**Position & phase:** 25 BPM  
**Trans. emittance:** 9 Slit-Grid, 1 pepper-pot  
**Long. emittance:** 3 devices of different type



**Transport Lines:**  
**Current:** 8 FCT  
 15 Part. Detec.  
**Profile:** 10 SEM-Grid  
 26 MWPC  
 18 Screens  
**Position:** 8 BPM



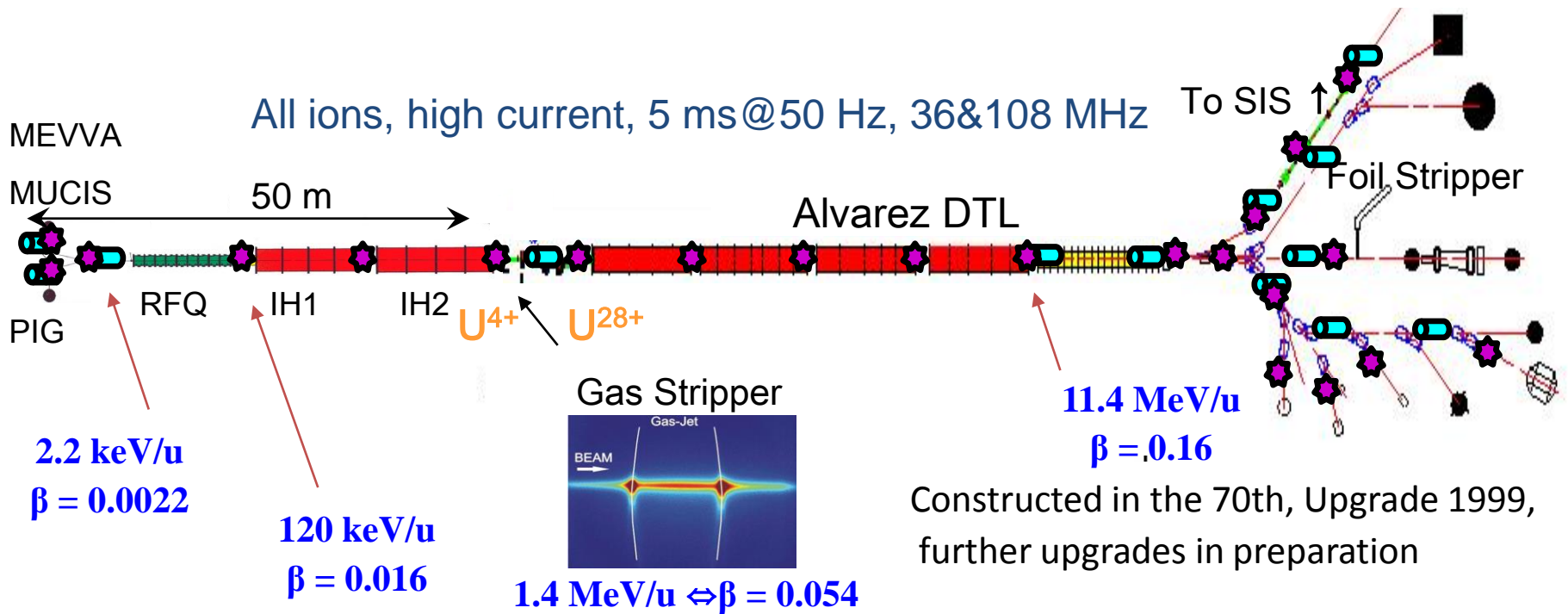
**Faraday Cup:** for low current measurement and beam stop, total 30



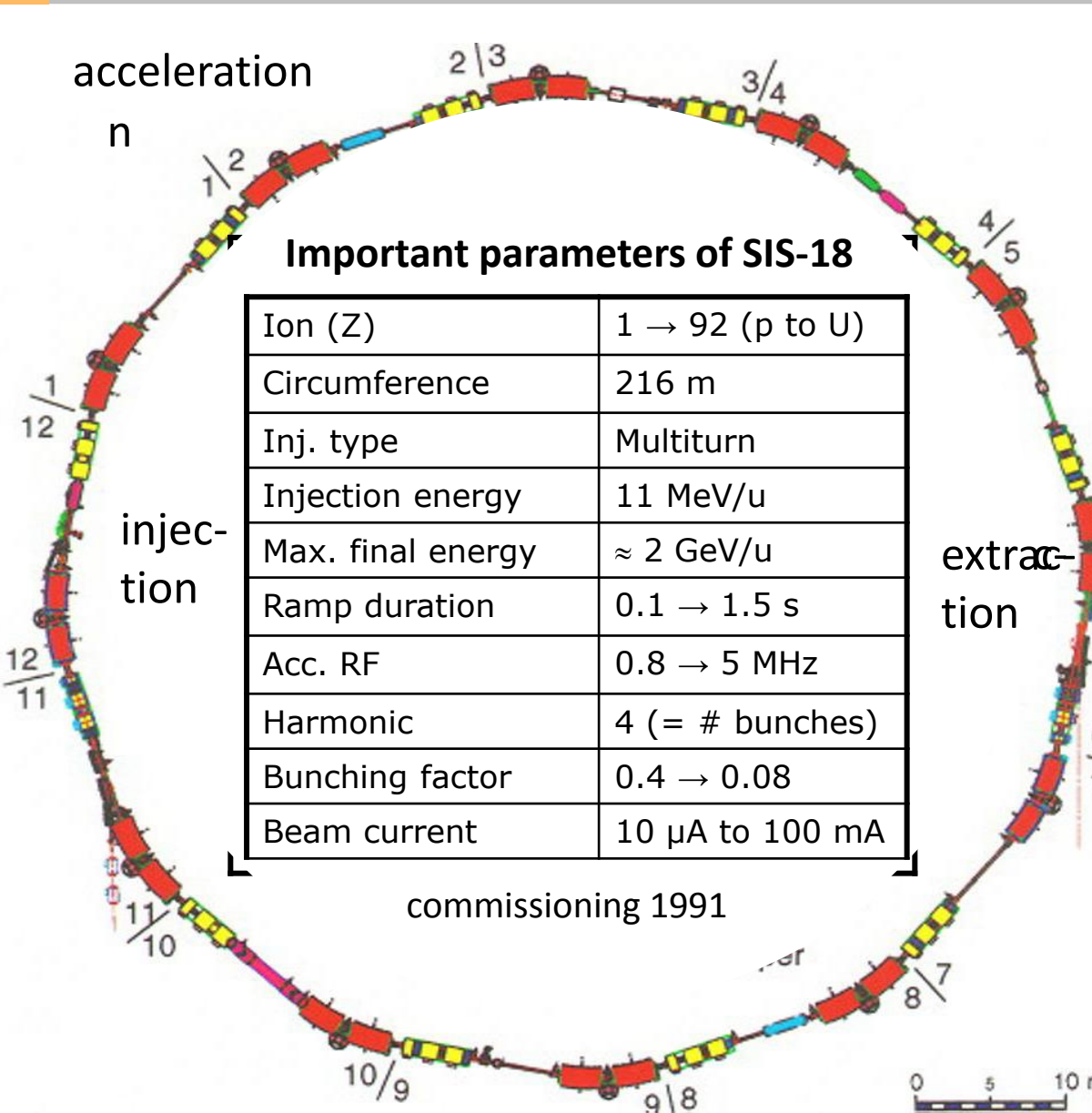
**Transformer ACCT:** for current measurement and transmission control total 52 device

They are used for alignment and interlock generation

Transfer to Synchrotron

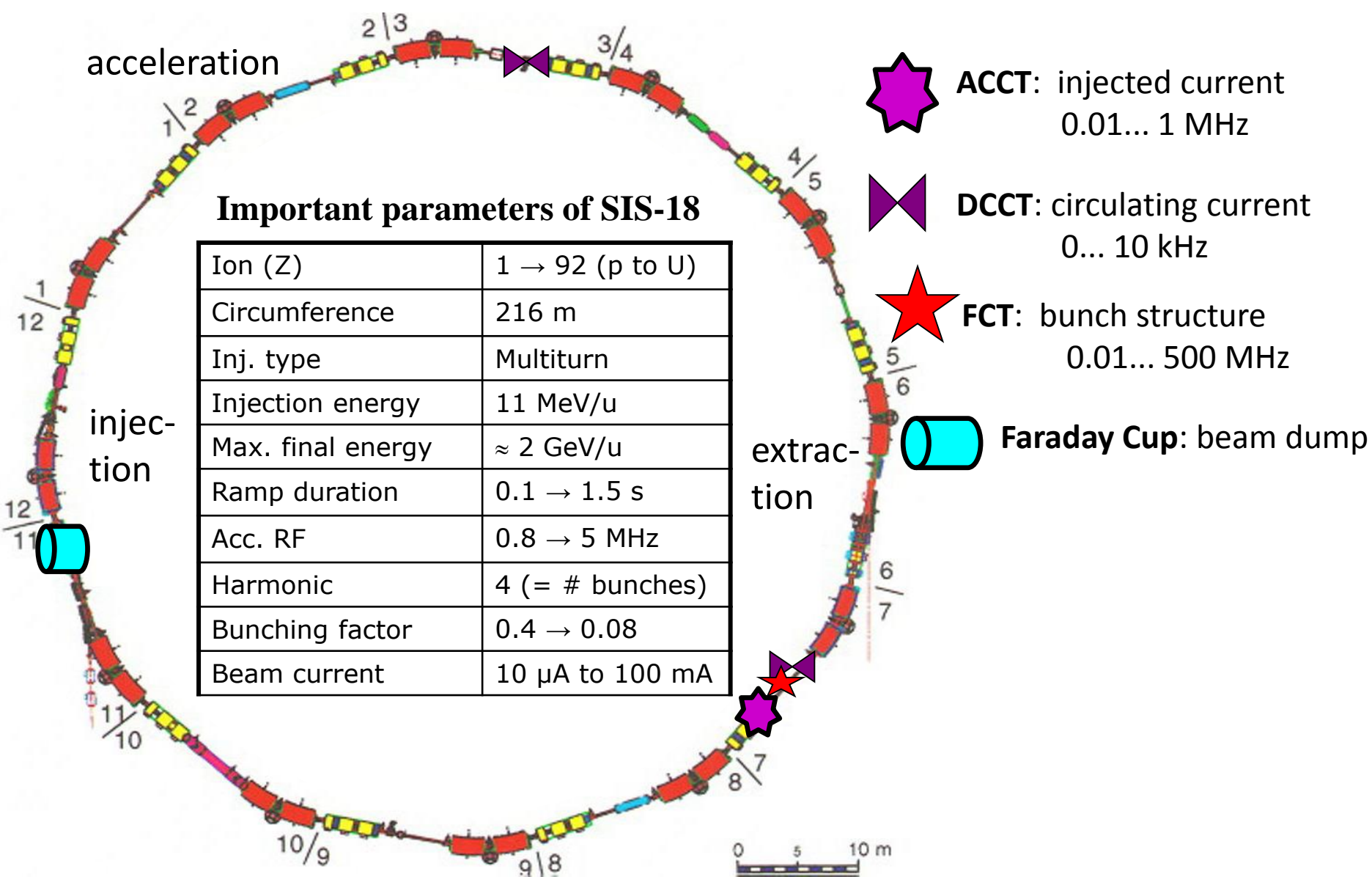


# Appendix: GSI Heavy Ion Synchrotron: Overview









# Appendix: GSI Heavy Ion Synchrotron: Current Measurement



## Important parameters of SIS-18

Ion (Z)	1 → 92 (p to U)
Circumference	216 m
Inj. type	Multiturn
Injection energy	11 MeV/u
Max. final energy	≈ 2 GeV/u
Ramp duration	0.1 → 1.5 s
Acc. RF	0.8 → 5 MHz
Harmonic	4 (= # bunches)
Bunching factor	0.4 → 0.08
Beam current	10 μA to 100 mA

-  **ACCT**: injected current  
0.01... 1 MHz
-  **DCCT**: circulating current  
0... 10 kHz
-  **FCT**: bunch structure  
0.01... 500 MHz
-  **Faraday Cup**: beam dump



Soleil, Paris,  $E_{electron} = 2.5$  GeV,  $C = 354$  m

## 3<sup>rd</sup> Generation Light Sources:

Synchrotron-based

with  $E_{electron} \approx 1...8$  GeV

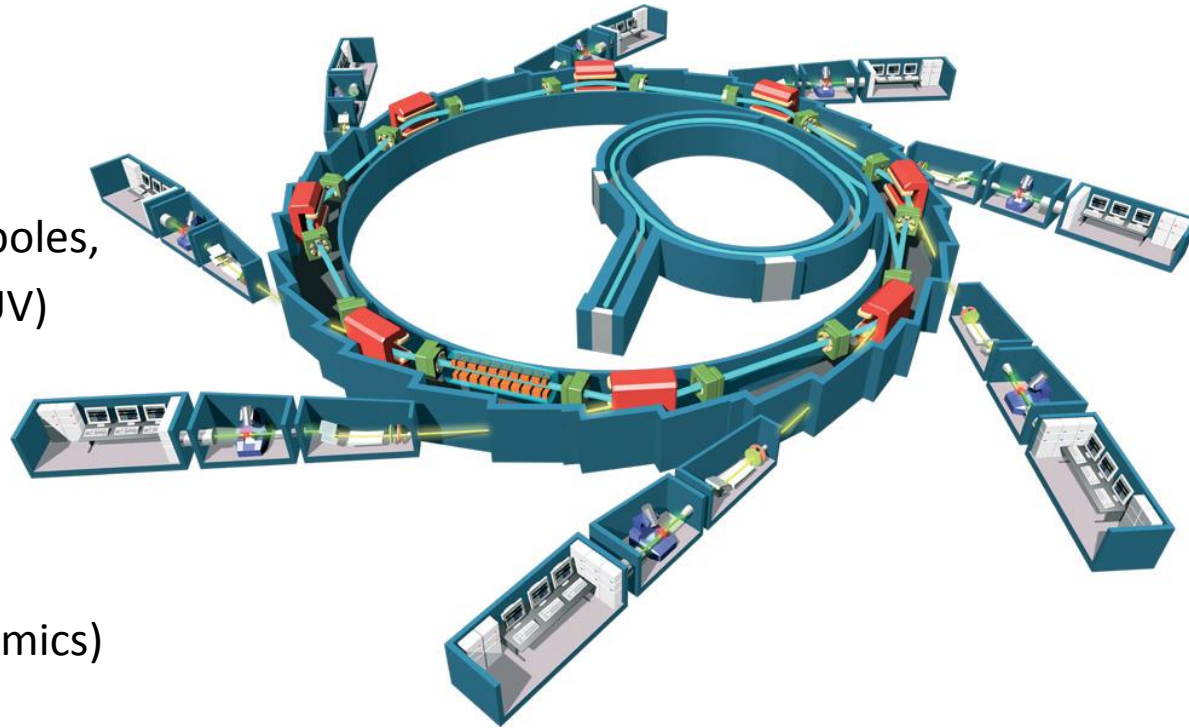
Light from undulators & wigglers, dipoles,  
with  $E_{\gamma} < 10$  keV (optical to deep UV)

**Users in:**

- Biology  
(e.g. protein crystallography)
- Chemistry  
(e.g. observation of reaction dynamics)
- material science  
(e.g. x-ray diffraction)
- Basic research in solid state and atomic physics

Unique setting: intense, broad-band light emission (monochromator for wavelength selection)

**National facilities in many counties, some international facilities.**



## 3<sup>rd</sup> generation Spanish national synchrotron light facility in Barcelona



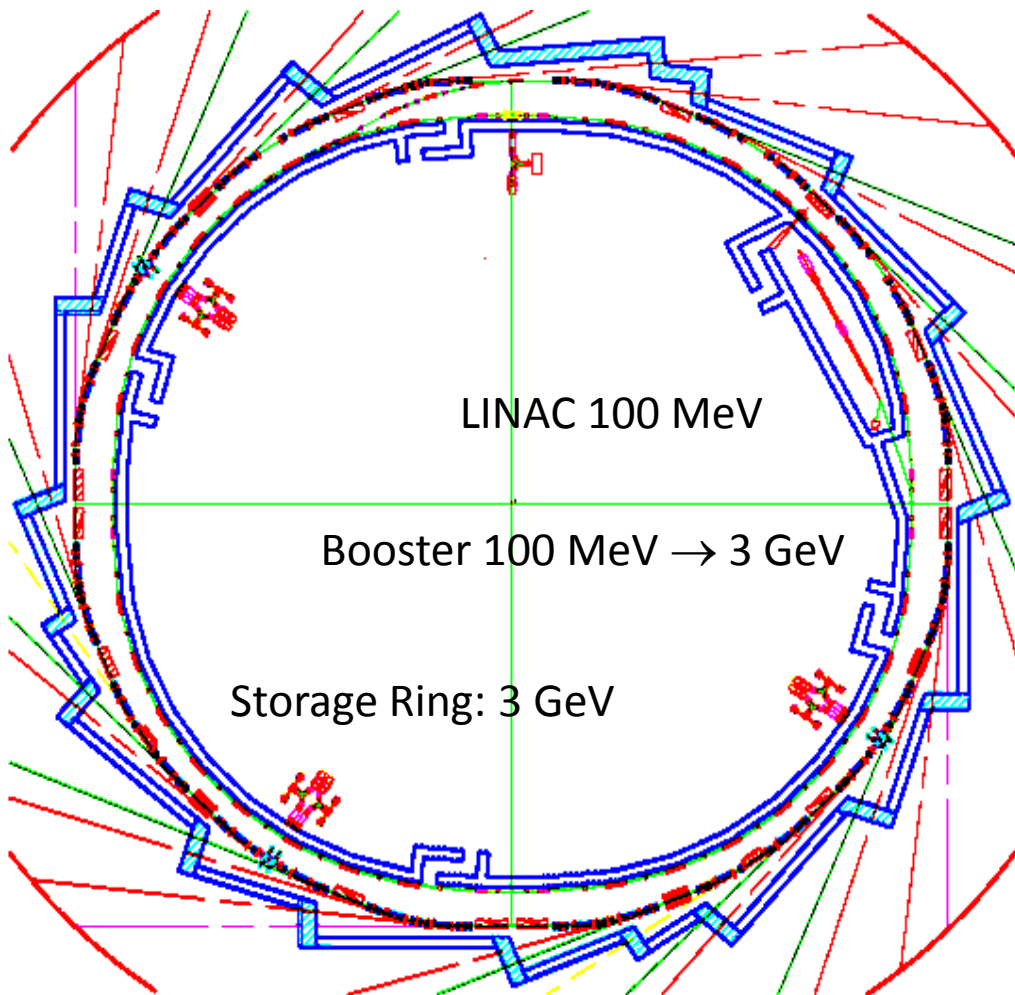
### Layout:

- Beam lines: up to 30
- Electron energy: 3 GeV
- Top-up injection
- Storage ring length: 268 m
- Max. beam current: 0.4 A
- Commissioning in 2011



Talk by Ubaldo Iriso: at DIPAC 2011, [adweb.desy.de/mpy/DIPAC2011/html/session.htm](http://adweb.desy.de/mpy/DIPAC2011/html/session.htm)  
see also [www.cells.es/Divisions/Accelerators/RF\\_Diagnostics/Diagnostics](http://www.cells.es/Divisions/Accelerators/RF_Diagnostics/Diagnostics)

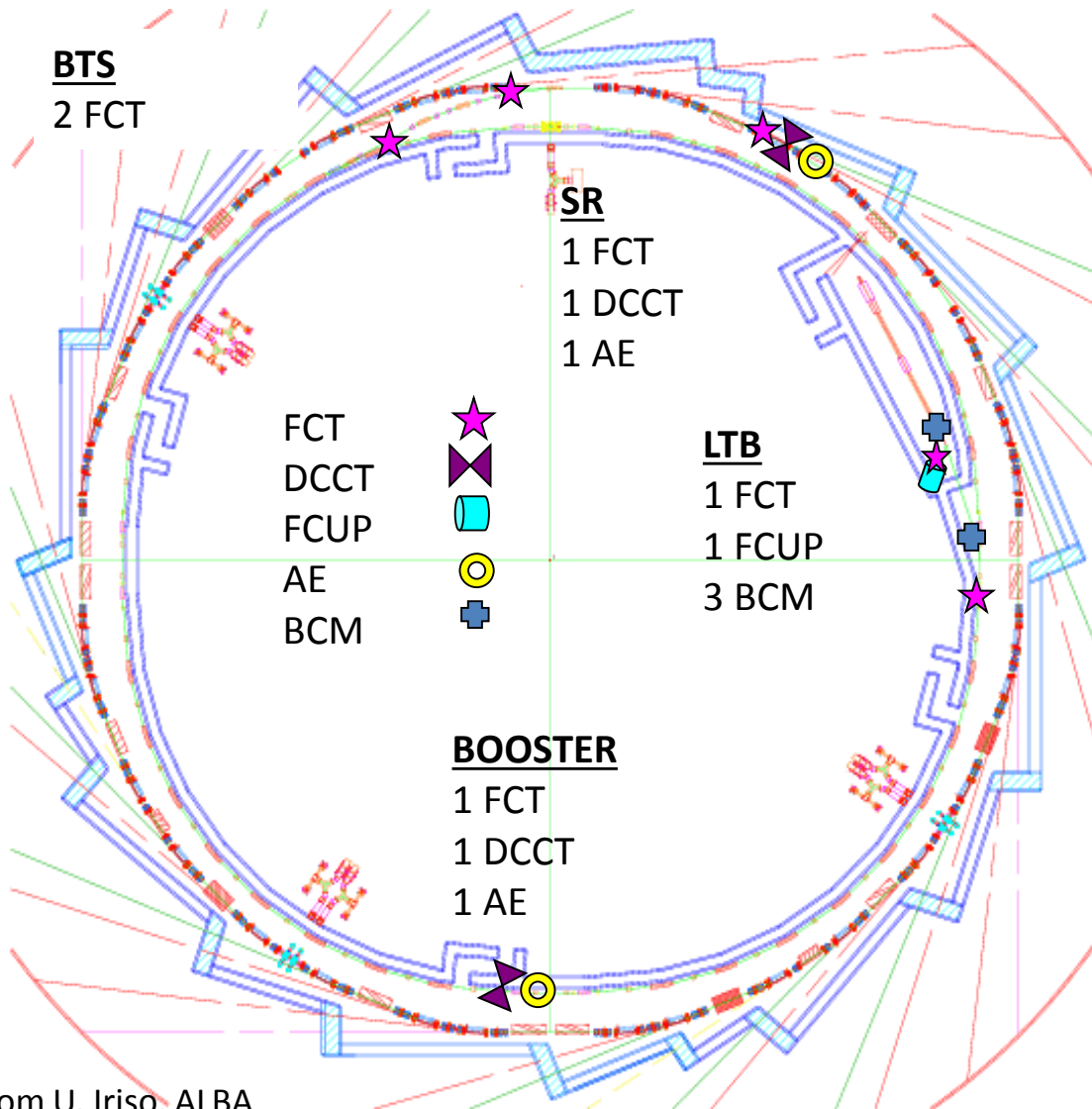
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From U. Iriso, ALBA



## Beam current:

Amount of electrons accelerated, transported and stored

- Several in transport lines
- One per ring

## Abbreviation:

- FCT:** Fast Current Transformer
- DCCT:** dc transformer
- FCUP:** Faraday Cup
- AE:** Annular Electrode
- BCM:** Bunch Charge Monitor

## Remark:

AE: Annular Electrode  
i.e. circular electrode acting like a high frequency pick-up

From U. Iriso, ALBA

## Current is the basic quantity for accelerators!

### **Transformer:** → measurement of the beam's magnetic field

- magnetic field is guided by a high  $\mu$  toroid
- types: passive (large bandwidth), active (low droop) and dc (two toroids + modulation)
- lower threshold by magnetic noise: about  $I_{beam} > 1 \mu\text{A}$
- non-destructive, used for all beams

### **Faraday cup:** → measurement of beam's charge

- low threshold by I/U-converter:  $I_{beam} > 10 \text{ pA}$
- totally destructive, used for low energy beams

### **Scintillator,** → measurement of the particle's energy loss

#### **IC, SEM:**

- particle counting (Scintillator)
- secondary current: **IC** from gas ionization or **SEM** sec.  $e^-$  emission surface
- no lower threshold due to single particle counting
- partly destructive, used for high energy beams

## Backup slides

# Faraday Cups for high Intensity Ion Beam → Surface Heating

The heating of material has to be considered, given by the energy loss.

The cooling is done by radiation due to Stefan-Boltzmann:  $P_r = \epsilon \sigma T^4$

**Example:** Beam current: 11.4 MeV/u Ar<sup>10+</sup> with 10 mA and 1 ms beam delivery

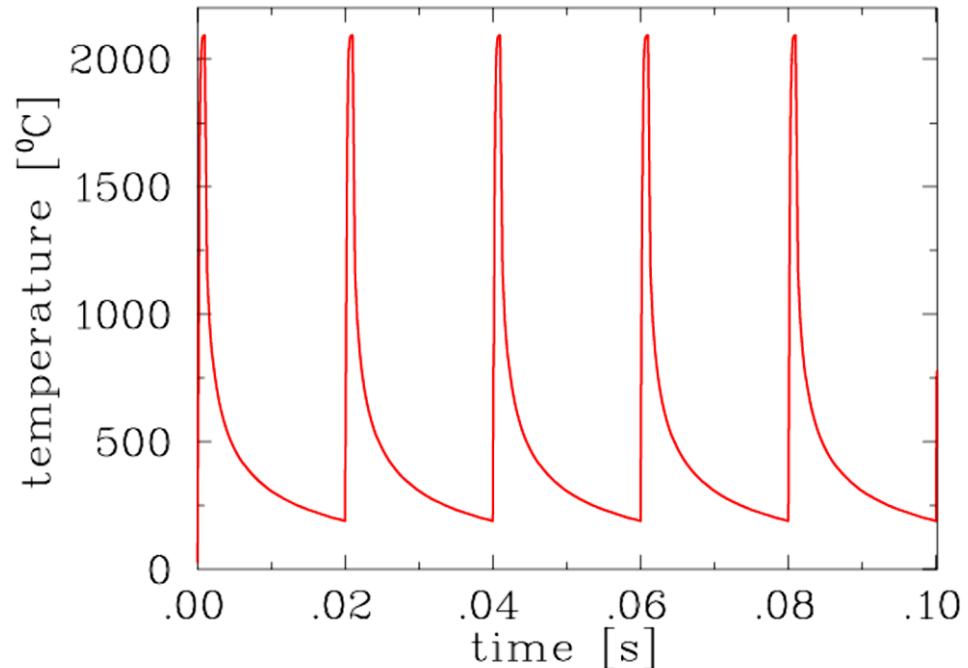
Beam size: 5 mm FWHM → 23 kW/mm<sup>2</sup>,  $P_{peak} = 450$  kW total power during 1ms delivery

Foil: 1 μm Tantalum, emissivity  $\epsilon = 0.49$

Temperature increase:

T > 2000 °C during beam delivery

Even for low average power,  
the material should  
survive the peak power!





# High Power Faraday Cups

Cups designed for 1 MW, 1 ms pulse power → cone of Tungsten-coated Copper

Bismuth for high melting temperature and copper for large head conductivity.

Faraday Cup  
Ø60 mm

vacuum flange  
Ø150 mm

bellow  
compression  
for movement

pneumatic  
drive

